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(54) **DISPLAY PANEL AND MANUFACTURING METHOD THEREOF**

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(57)

**ABSTRACT**

**Publication Classification**

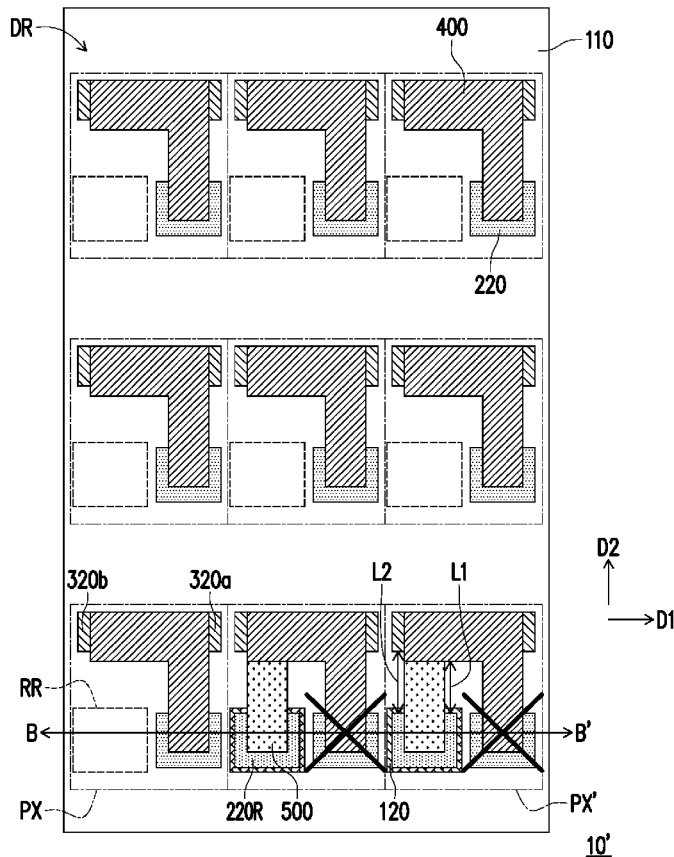
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*H01L 23/00* (2006.01)  
*H01L 25/16* (2006.01)

(52) **U.S. Cl.**

CPC ..... *H01L 33/62* (2013.01); *H01L 24/05* (2013.01); *H01L 24/24* (2013.01); *H01L 24/29* (2013.01); *H01L 24/82* (2013.01); *H01L 24/83* (2013.01); *H01L 24/92* (2013.01); *H01L 25/167* (2013.01); *H01L 24/06* (2013.01); *H01L 24/08* (2013.01); *H01L 24/25* (2013.01); *H01L 24/32* (2013.01); *H01L 24/73* (2013.01);

A display panel includes a circuit substrate, pixel structures and a molding layer. The circuit substrate has first pad structures and second pad structures. The pixel structures are disposed above a display region of the circuit substrate. Each of at least a portion of the pixel structures includes a first light emitting diode, a first conductive block, and a first conductive connection structure. The first light emitting diode is disposed on a corresponding first pad structure. The first conductive block is disposed on a corresponding second pad structure. The first conductive connection structure electrically connects the first light emitting diode to the first conductive block. The molding layer is located above the circuit substrate and surrounds the first light emitting diode and the first conductive block. The first conductive connection structure is located on the molding layer.



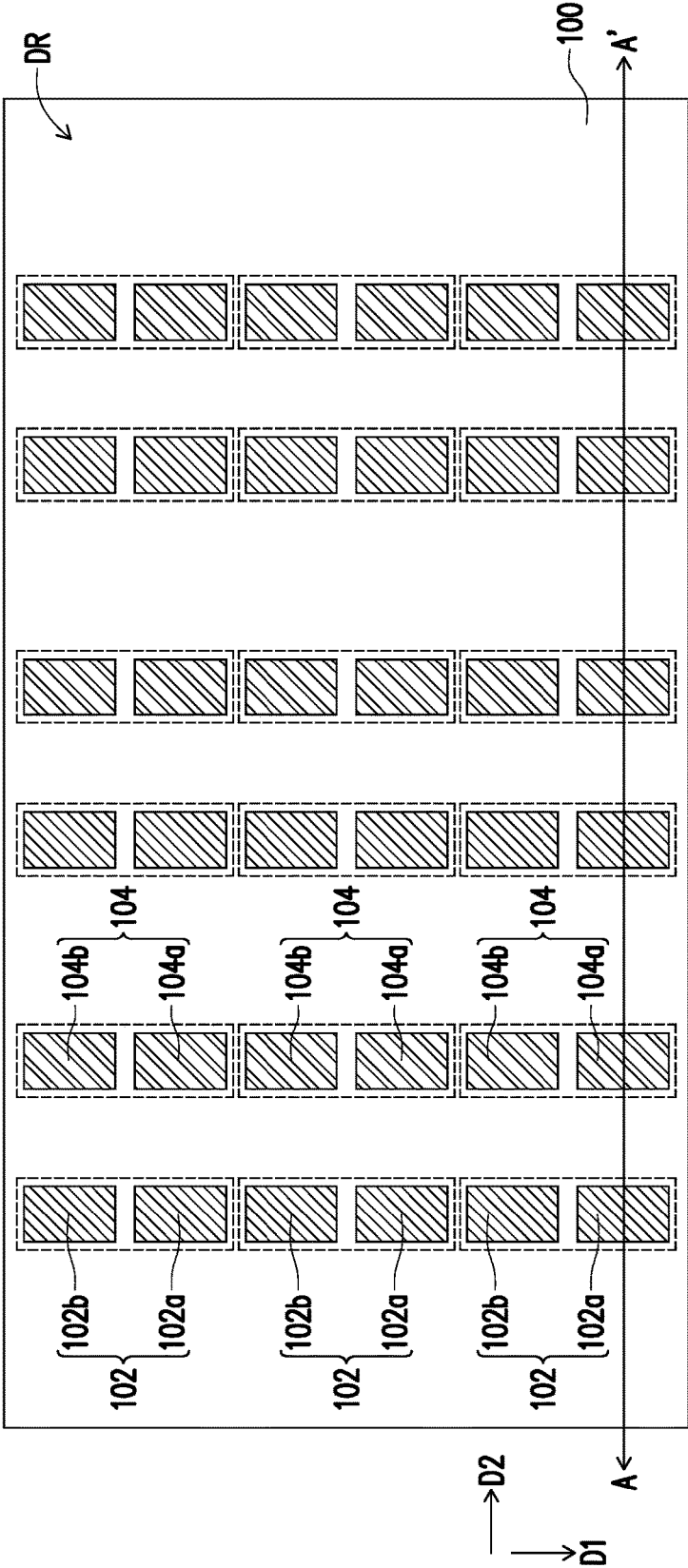


FIG. 1A

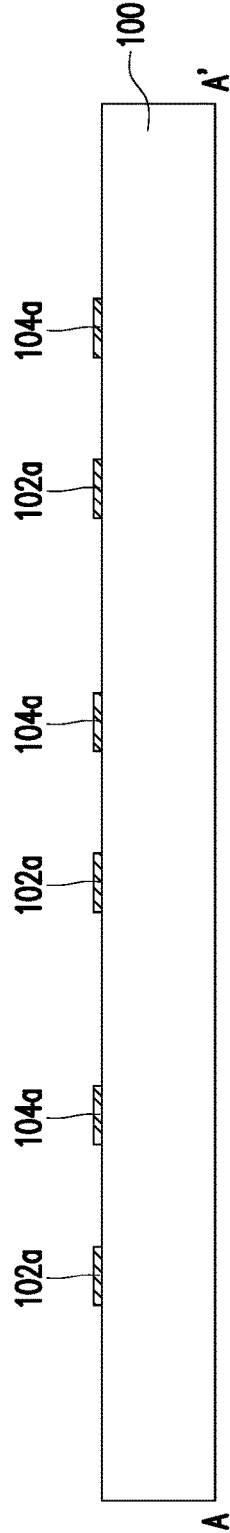


FIG. 1B

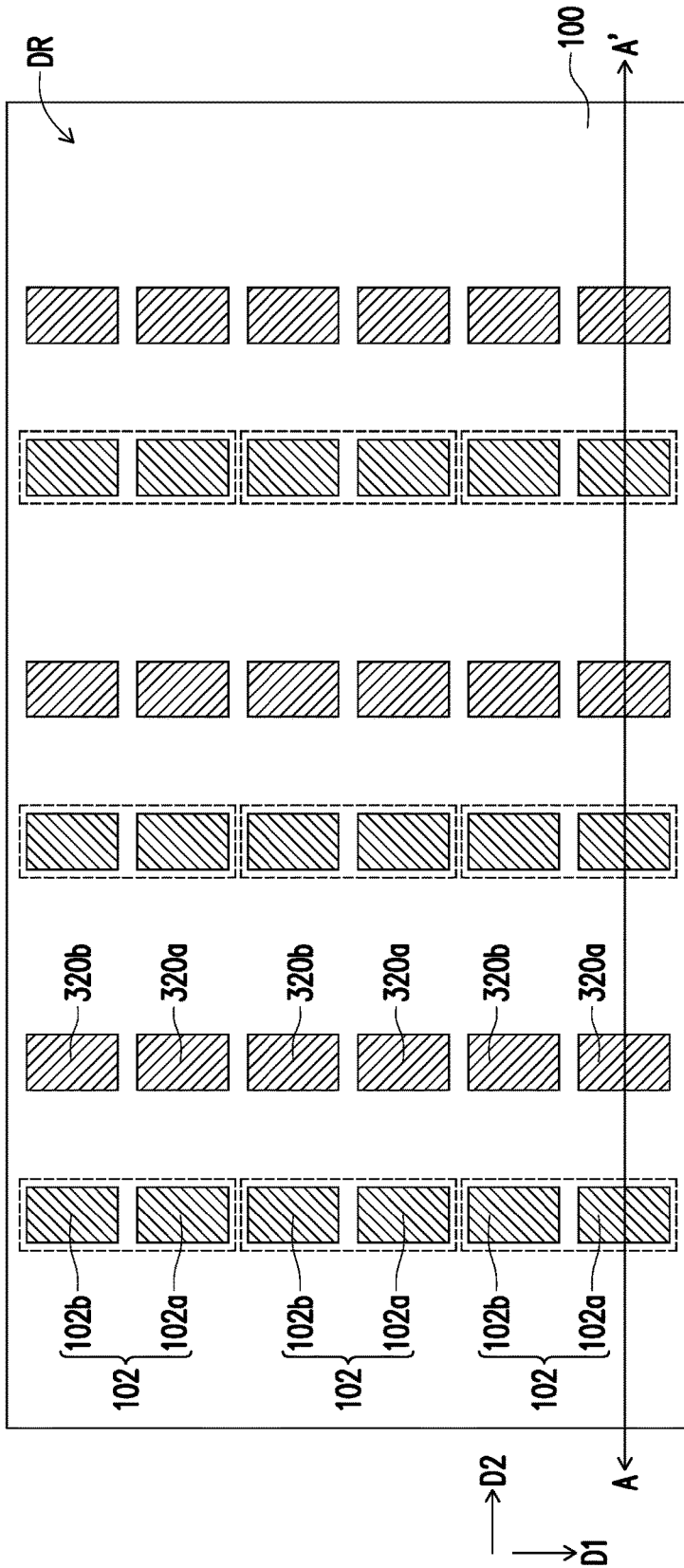


FIG. 2A

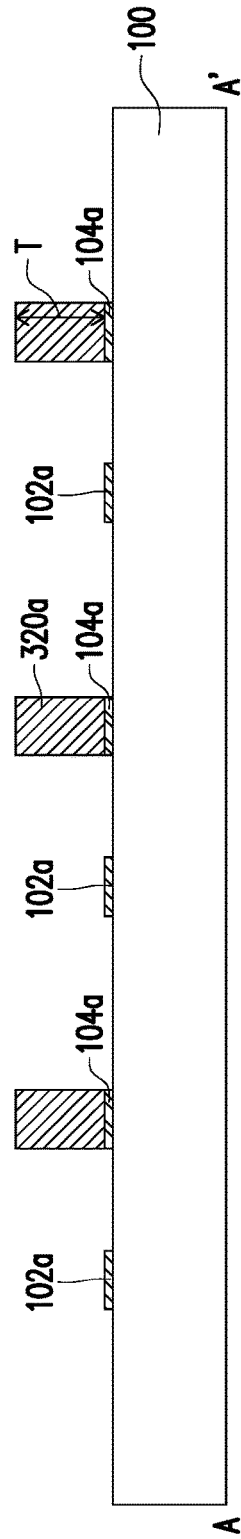


FIG. 2B

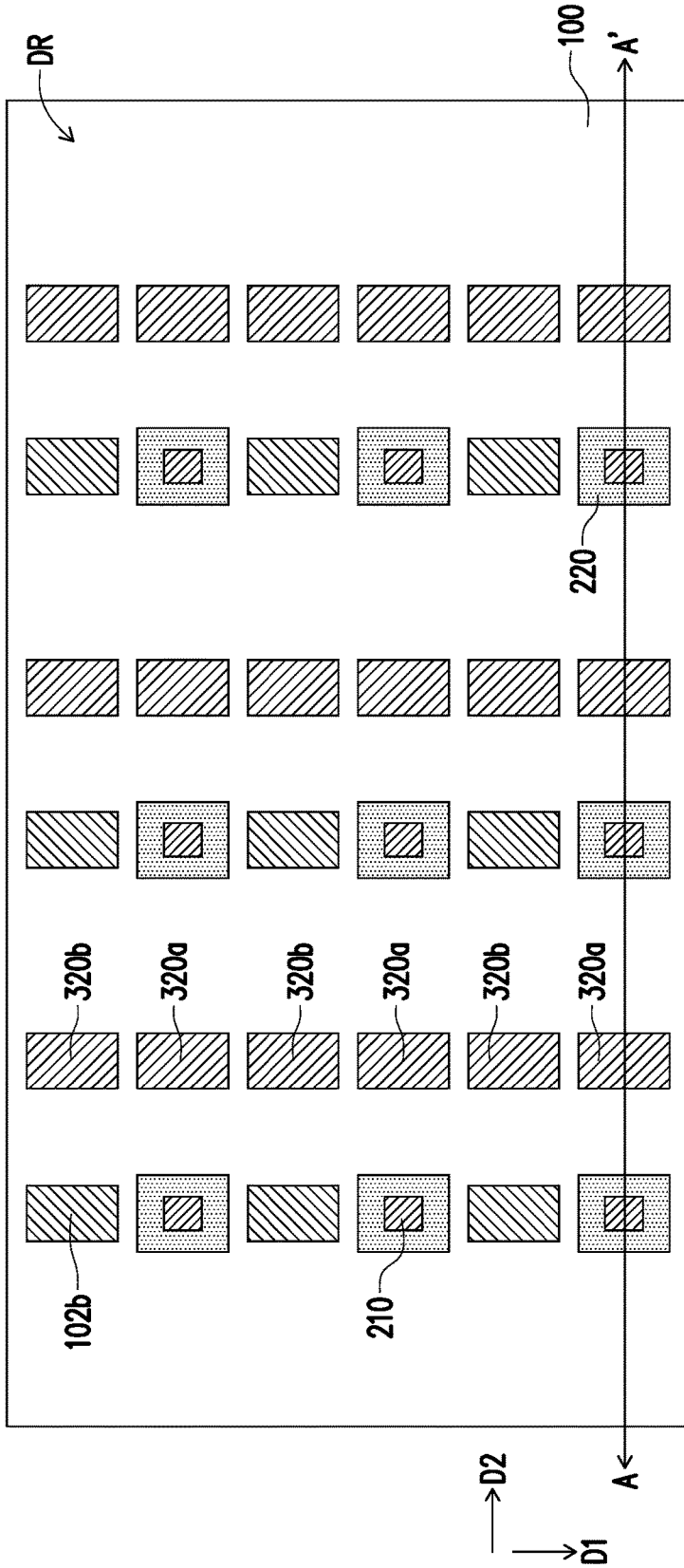


FIG. 3A

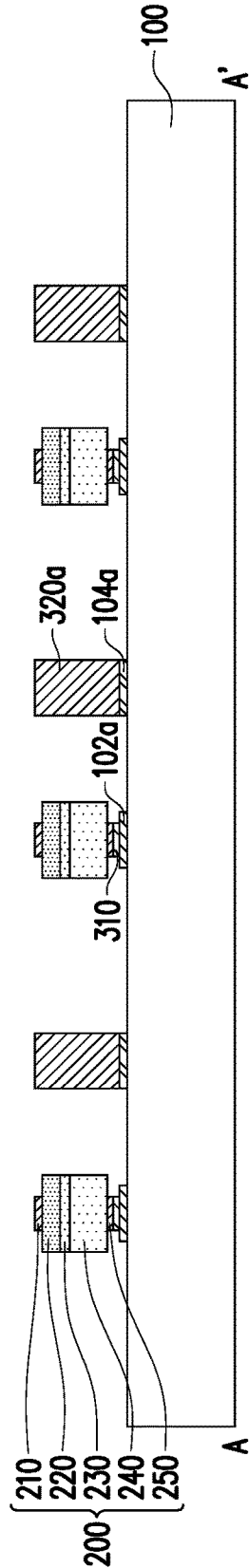


FIG. 3B

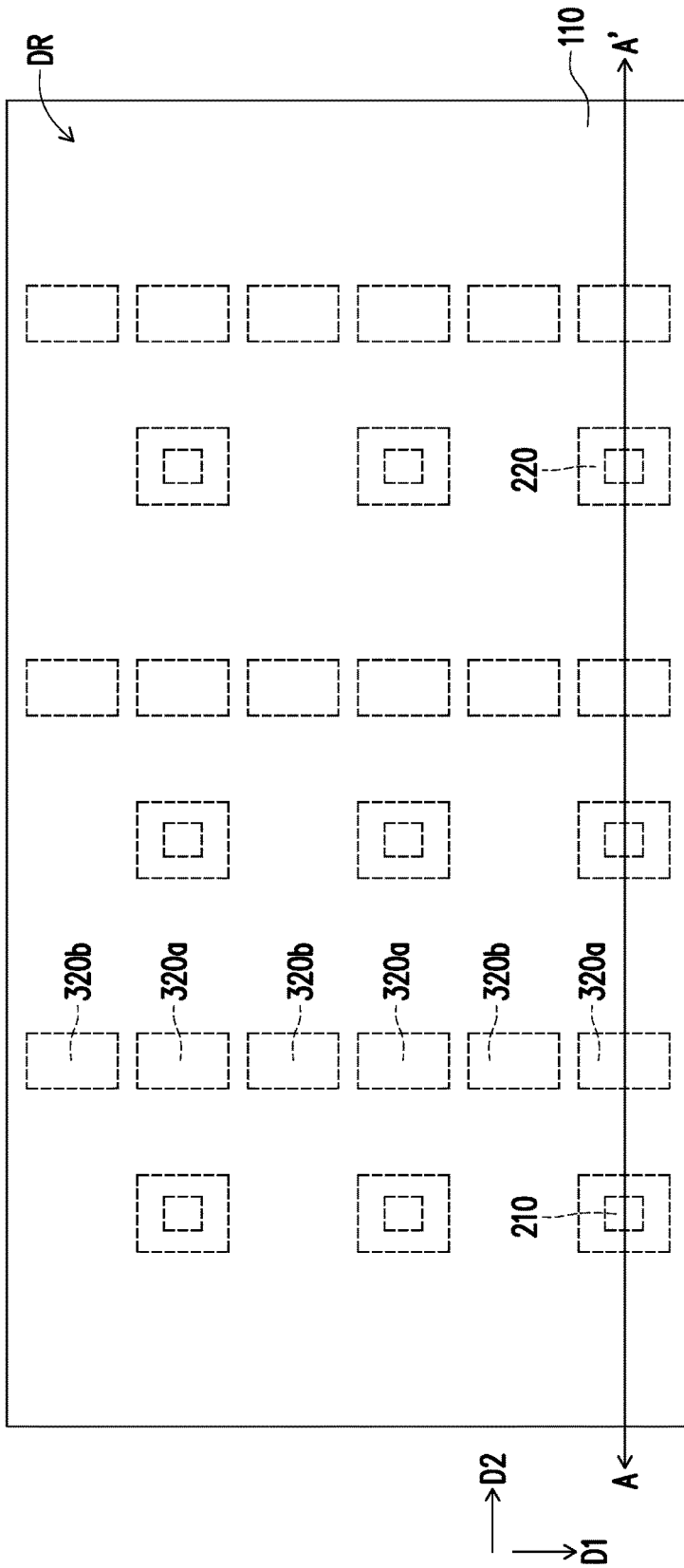


FIG. 4A

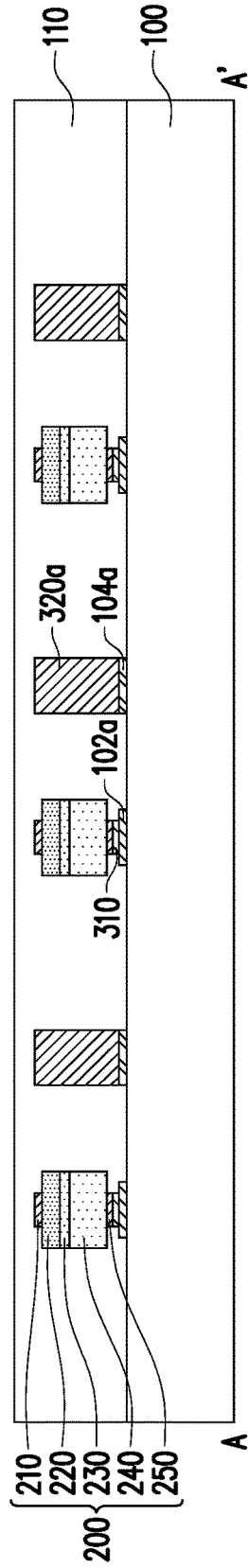


FIG. 4B

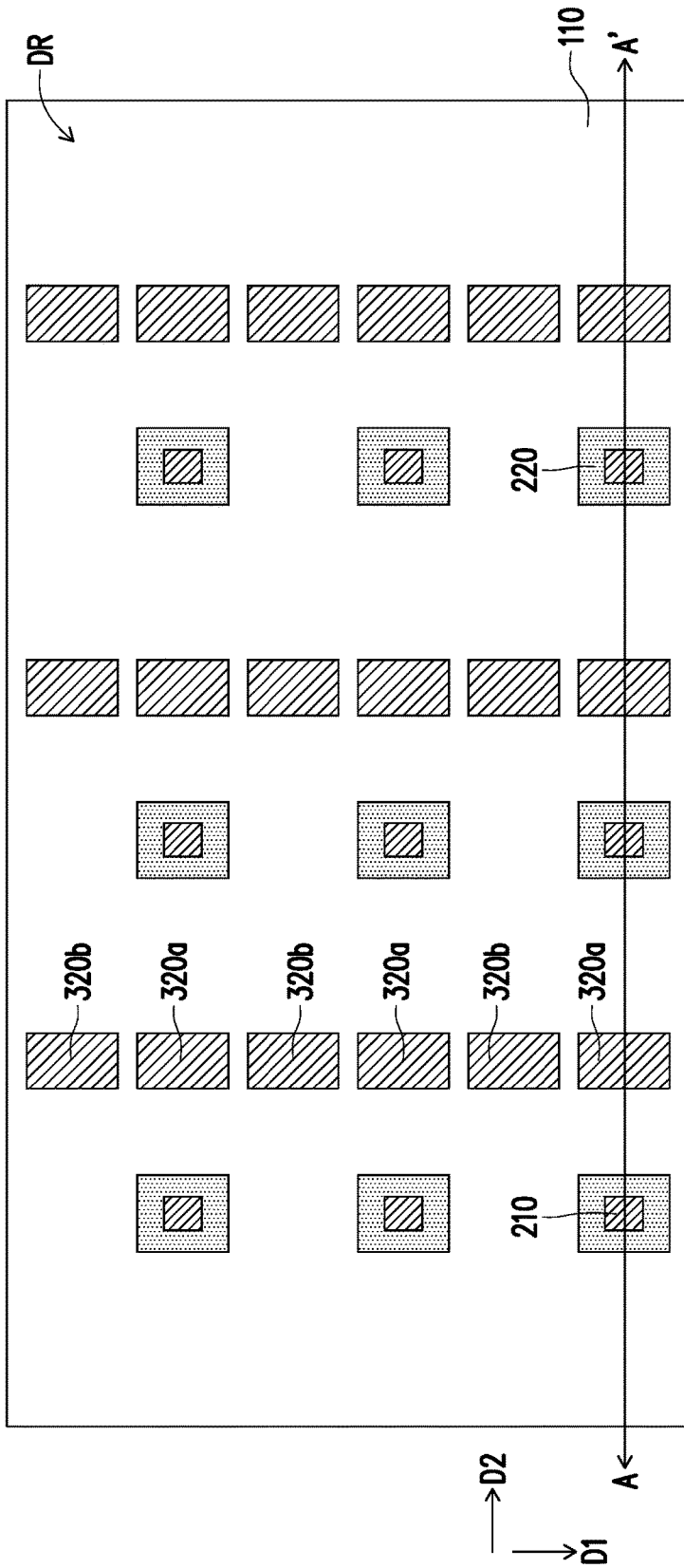


FIG. 5A

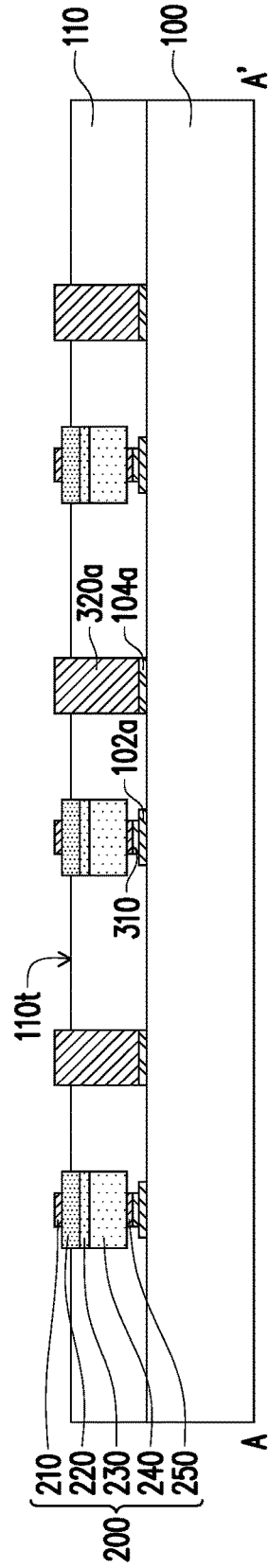


FIG. 5B

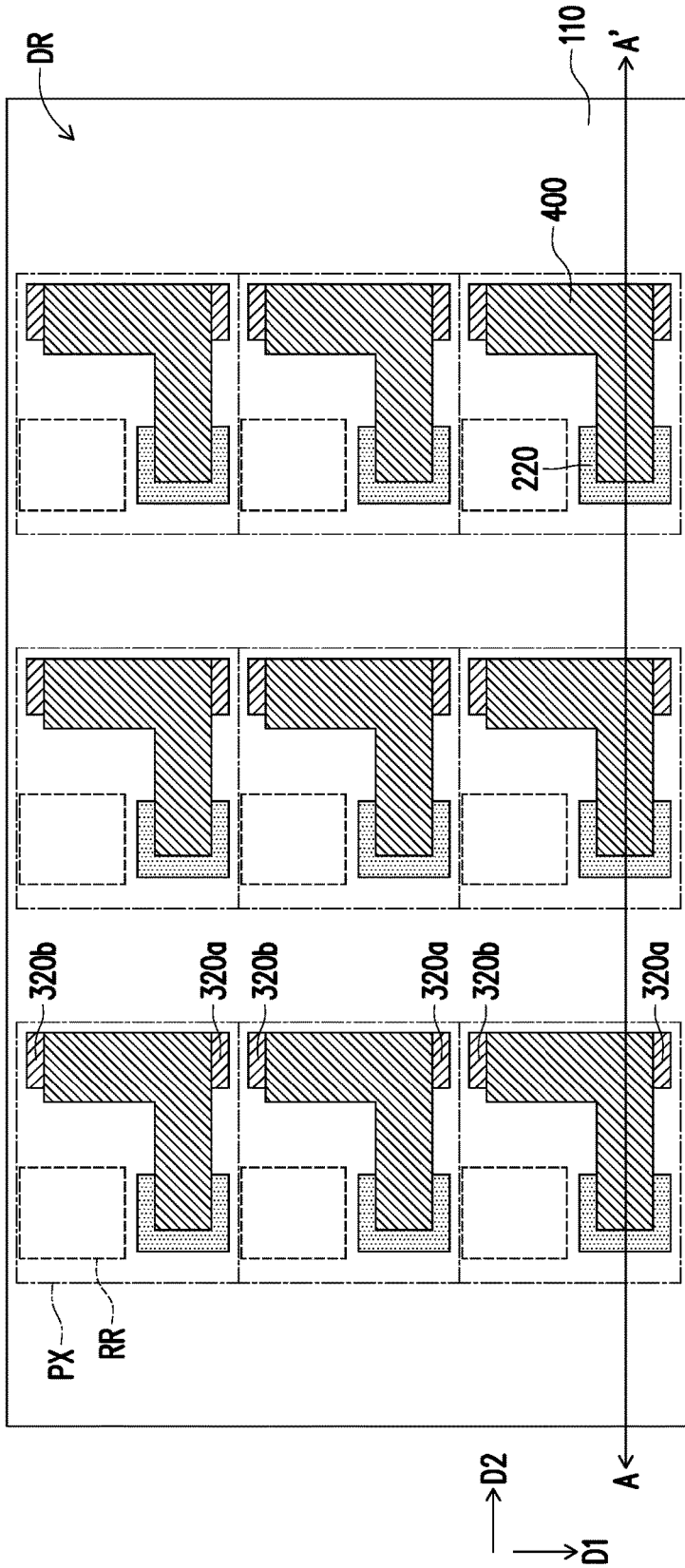


FIG. 6A

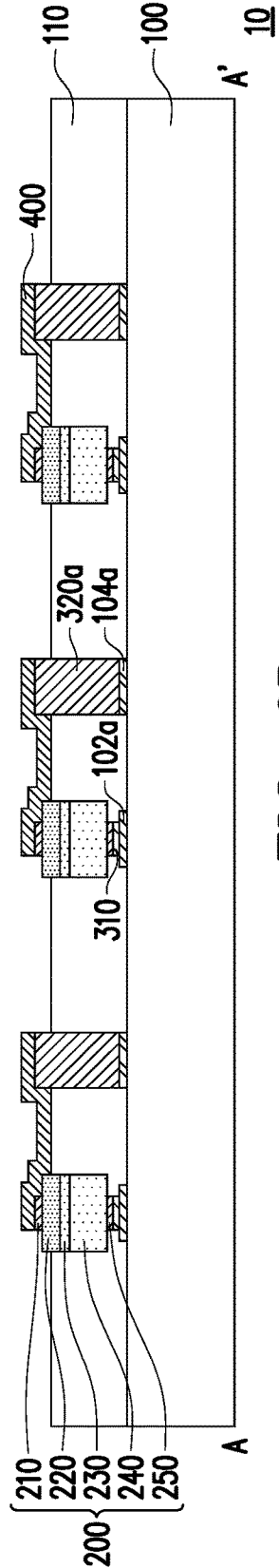


FIG. 6B

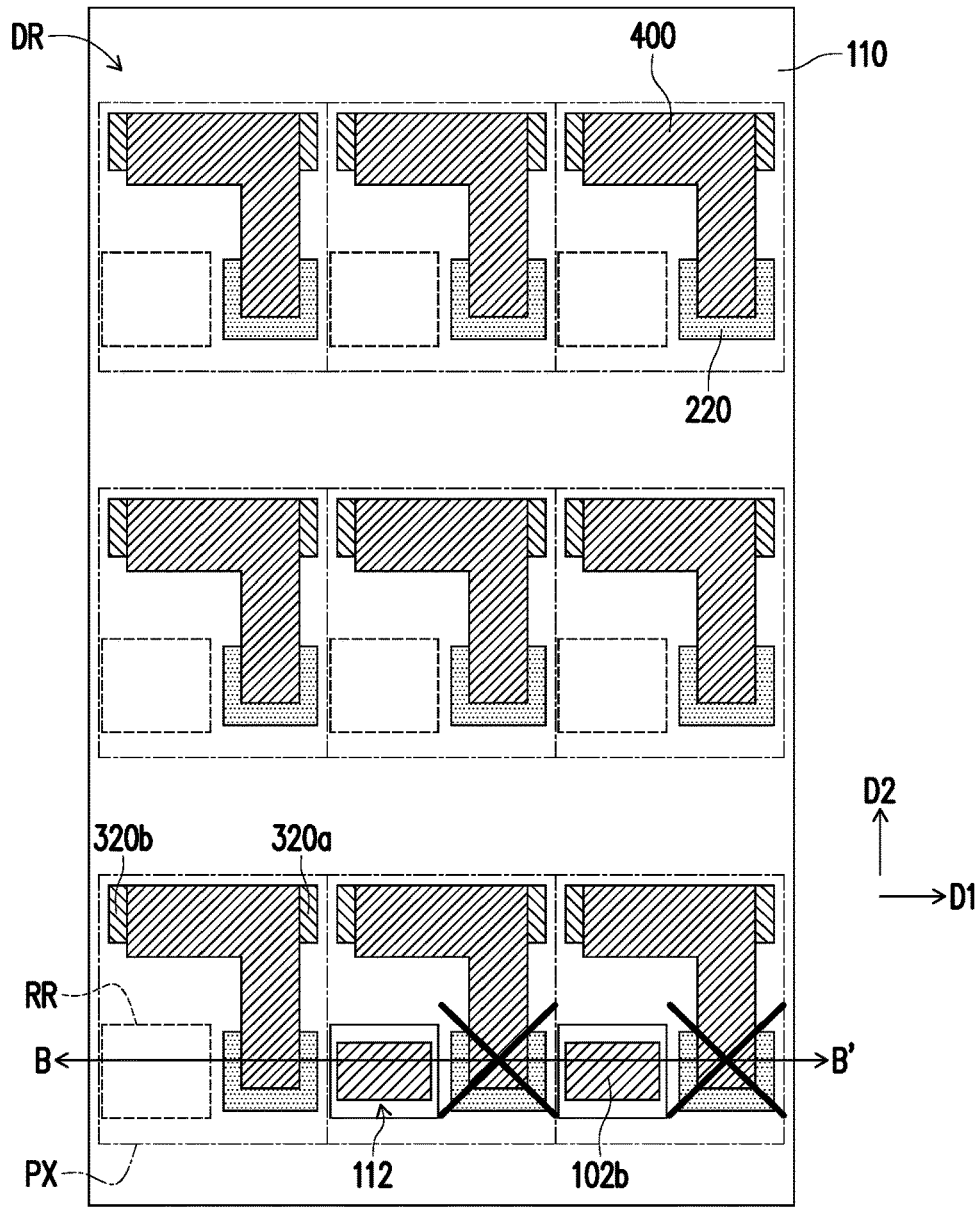


FIG. 7A

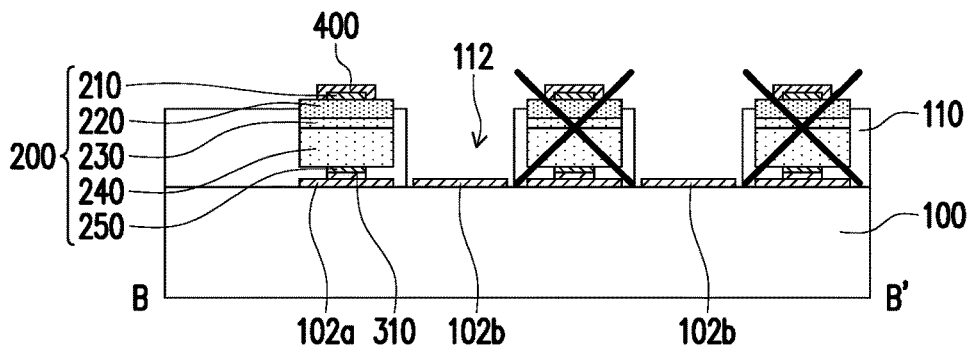


FIG. 7B



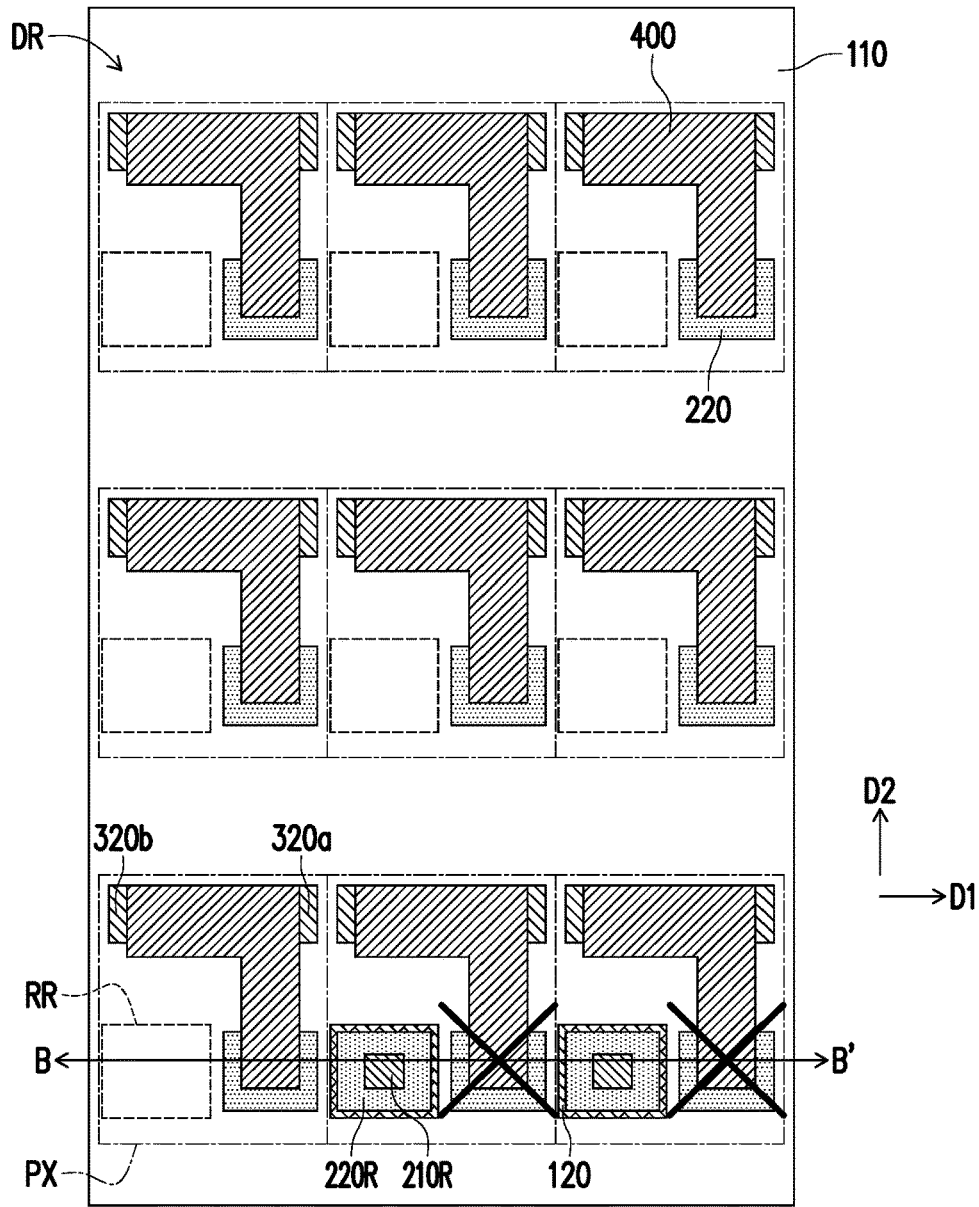


FIG. 8A

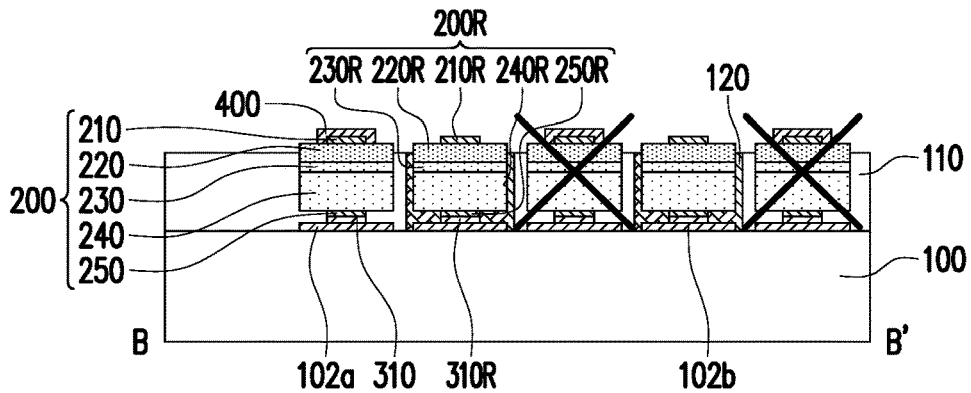


FIG. 8B

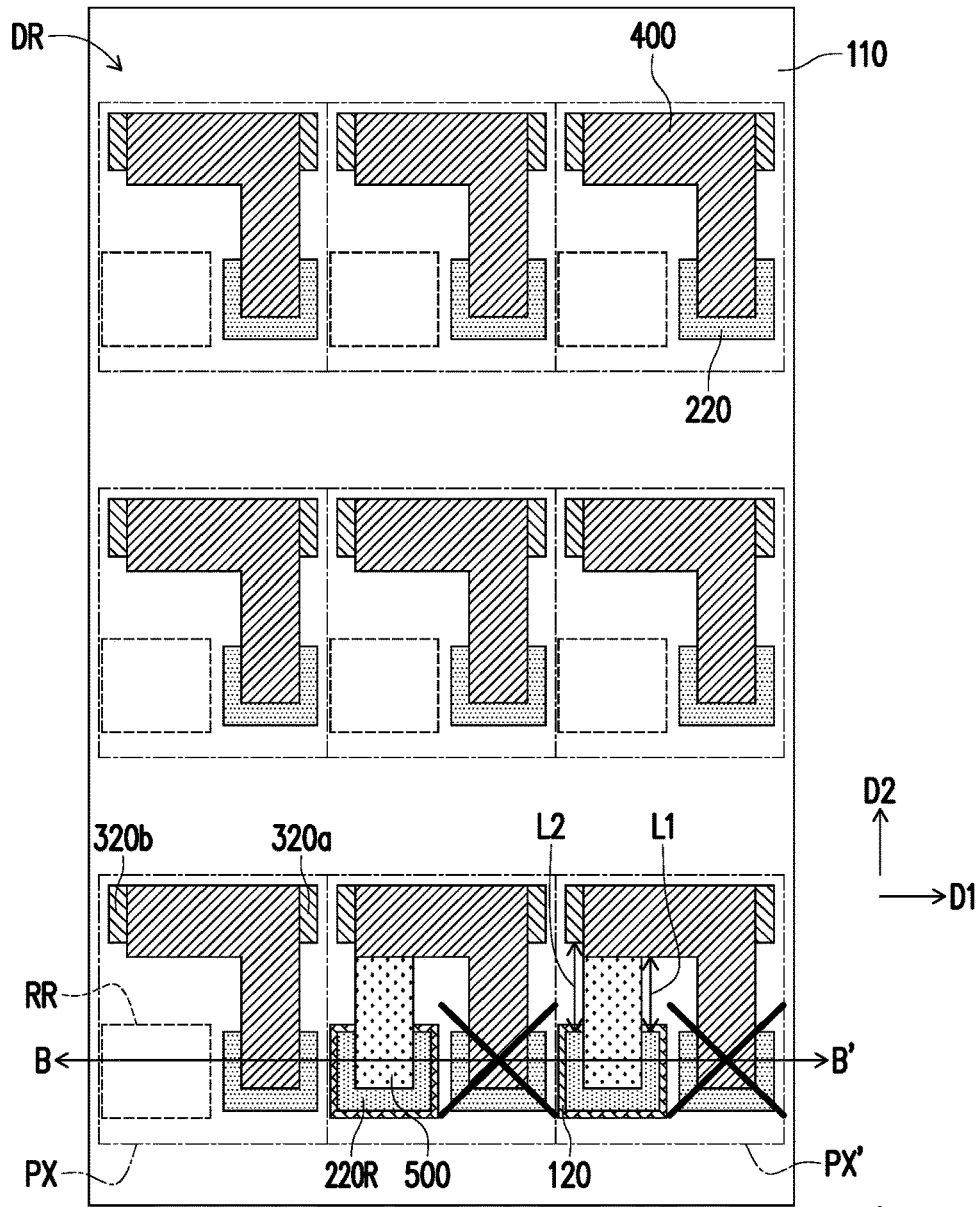


FIG. 9A

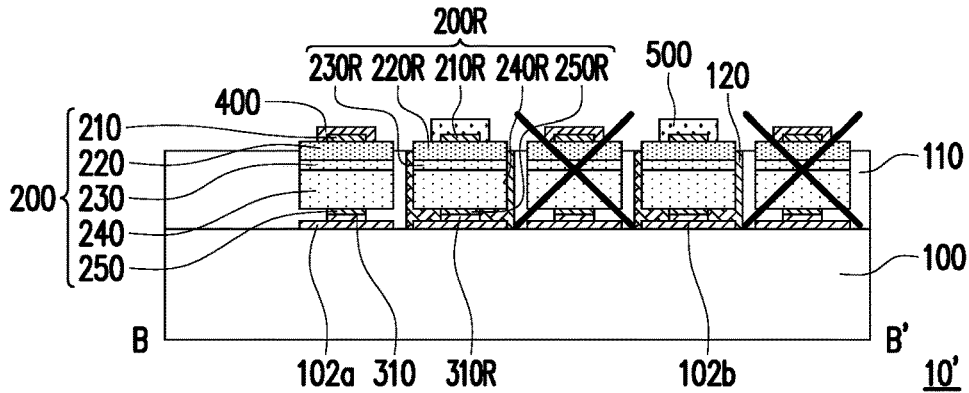


FIG. 9B

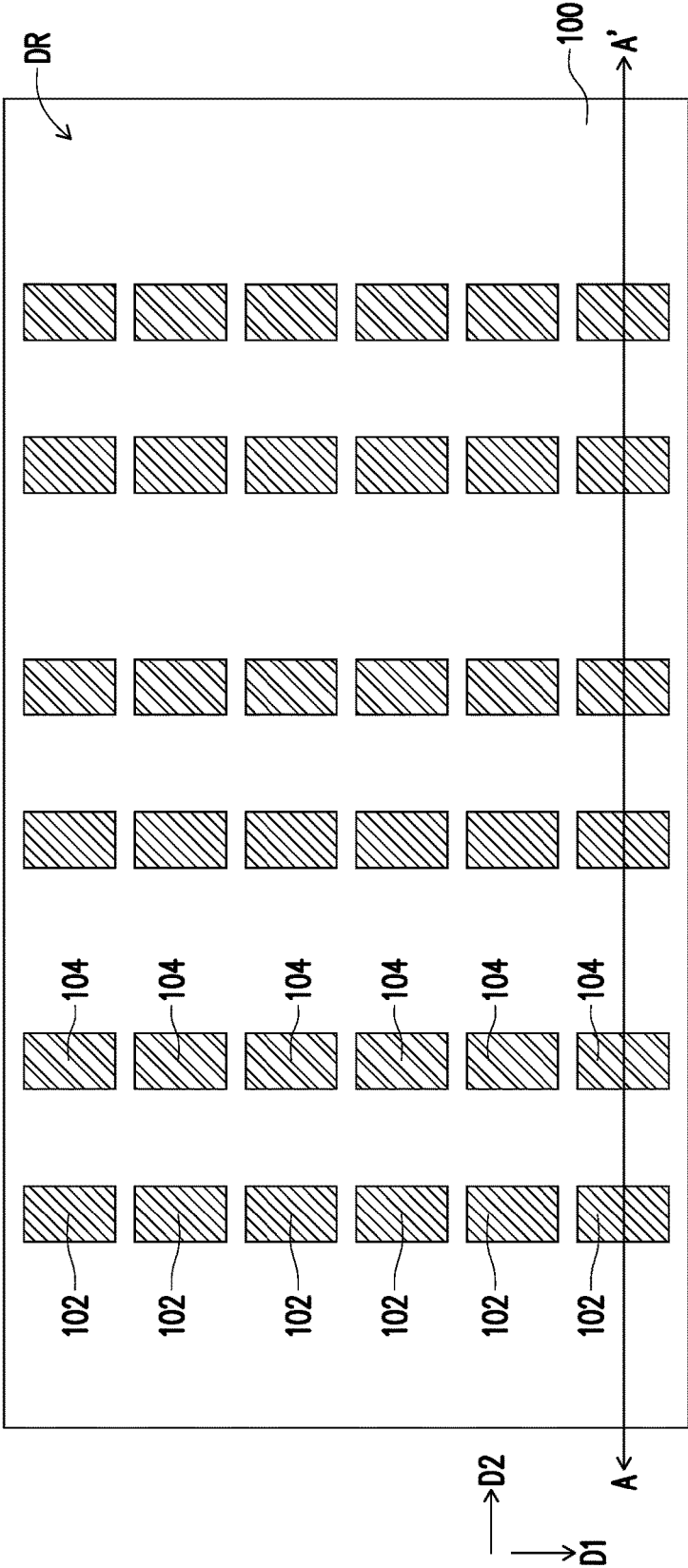


FIG. 10A

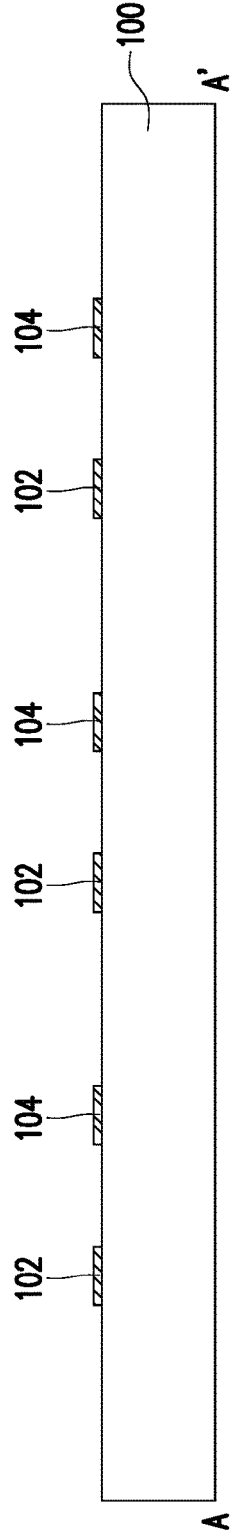


FIG. 10B

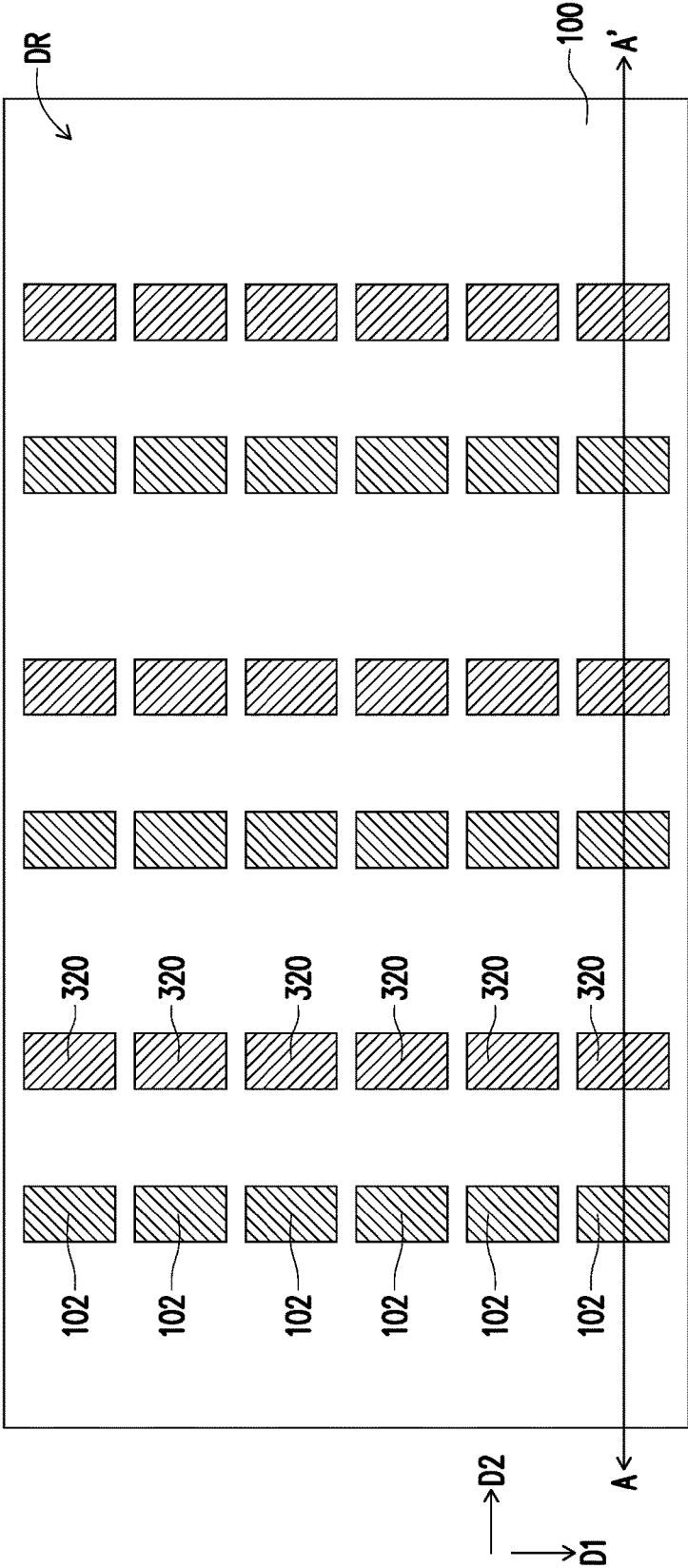


FIG. 11A

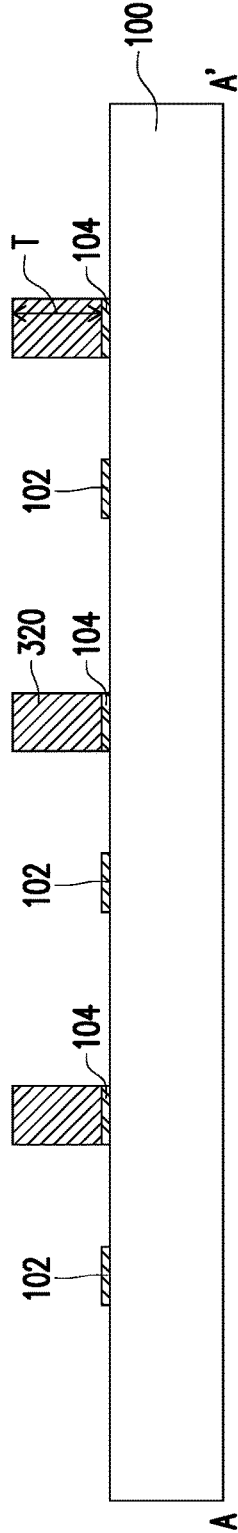


FIG. 11B

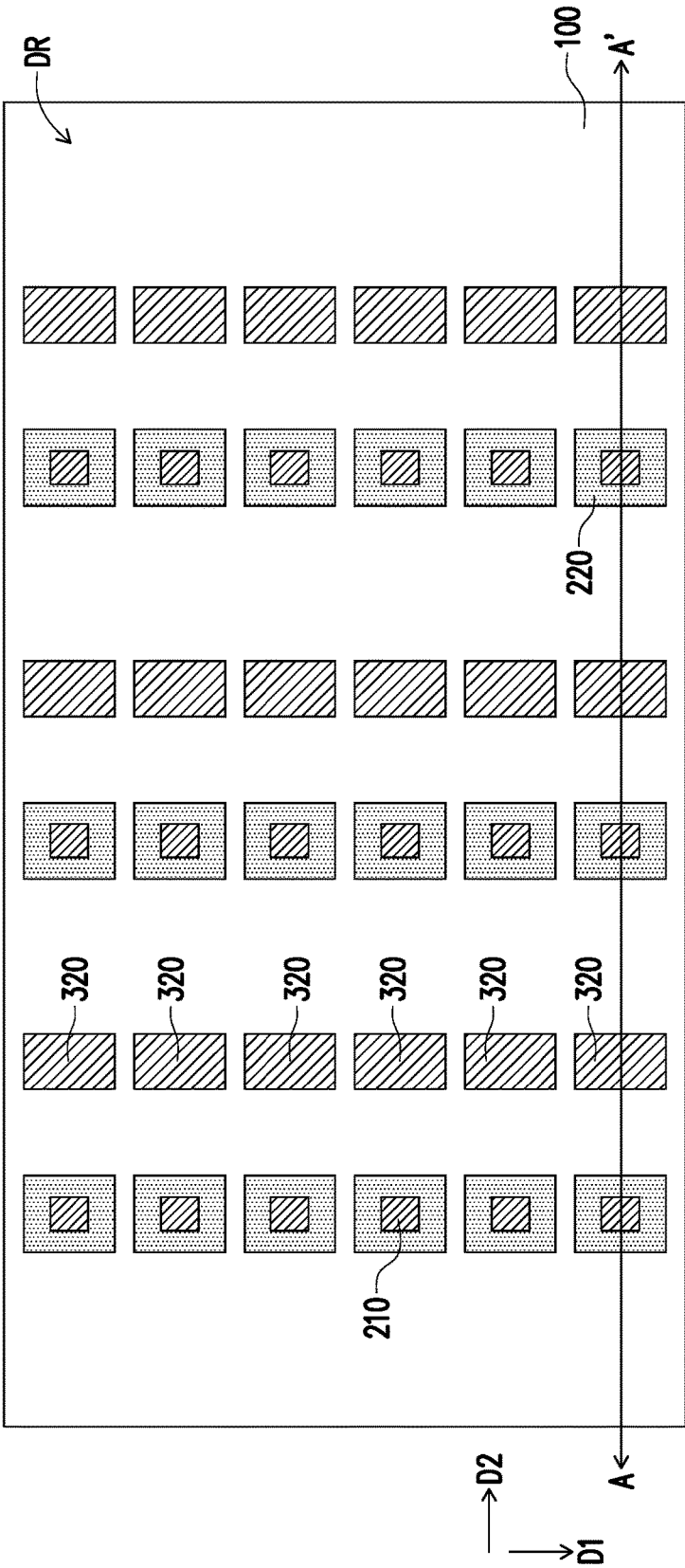


FIG. 12A

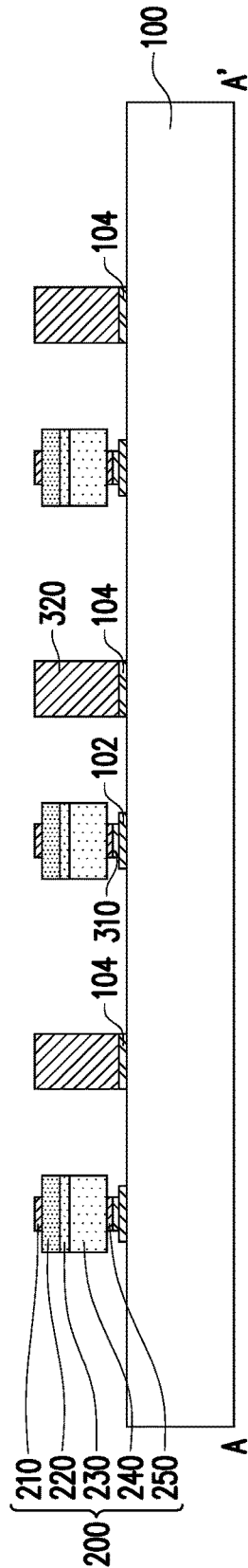


FIG. 12B

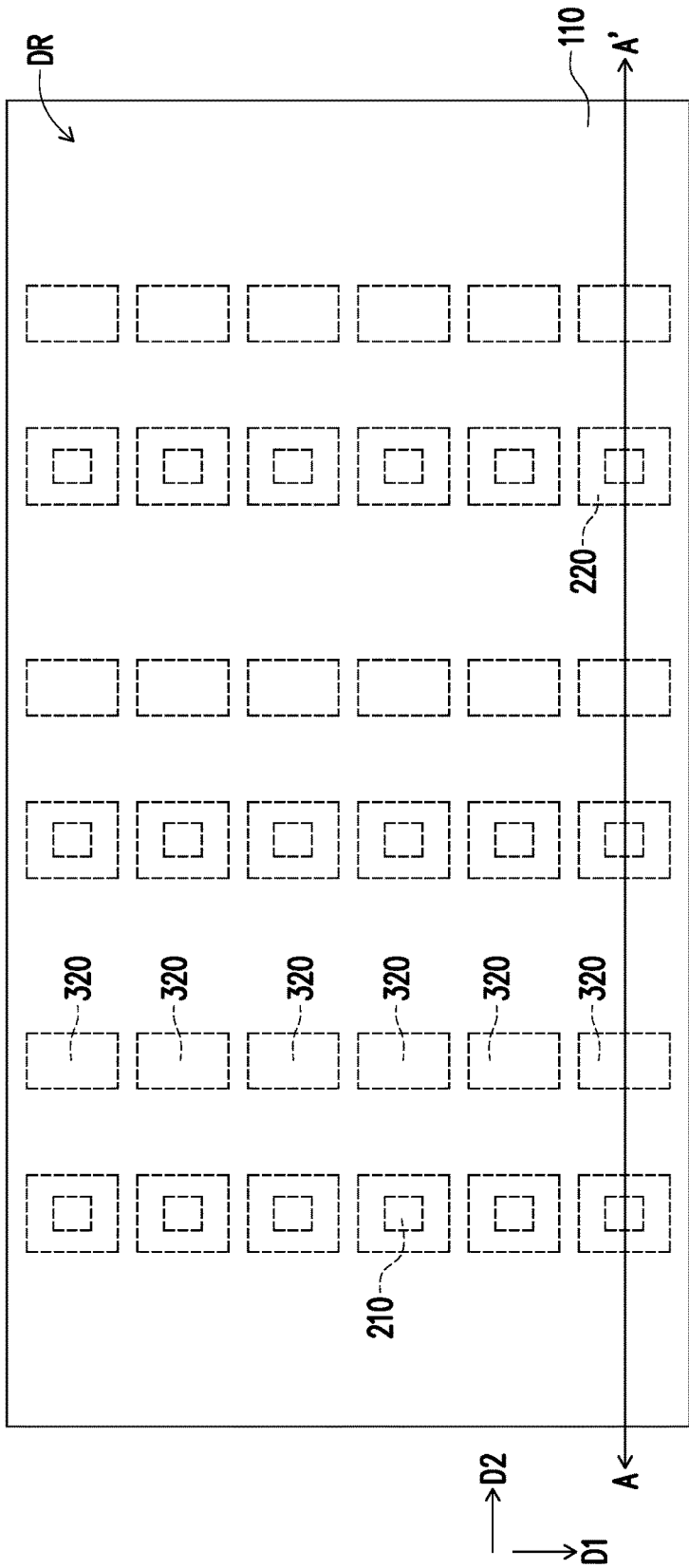


FIG. 13A

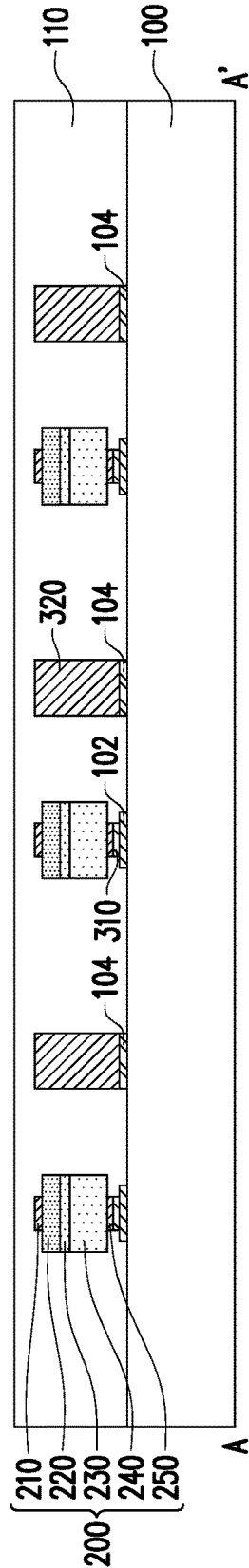


FIG. 13B

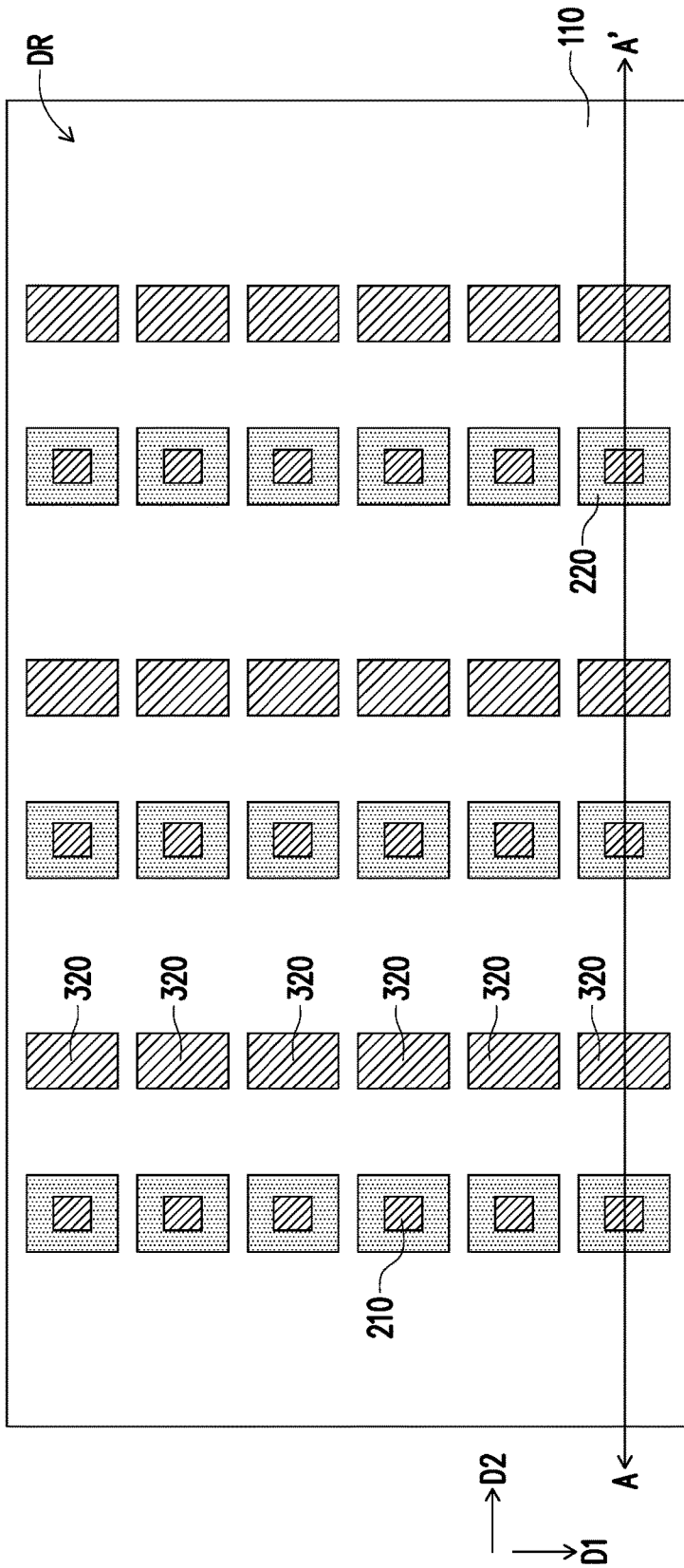


FIG. 14A

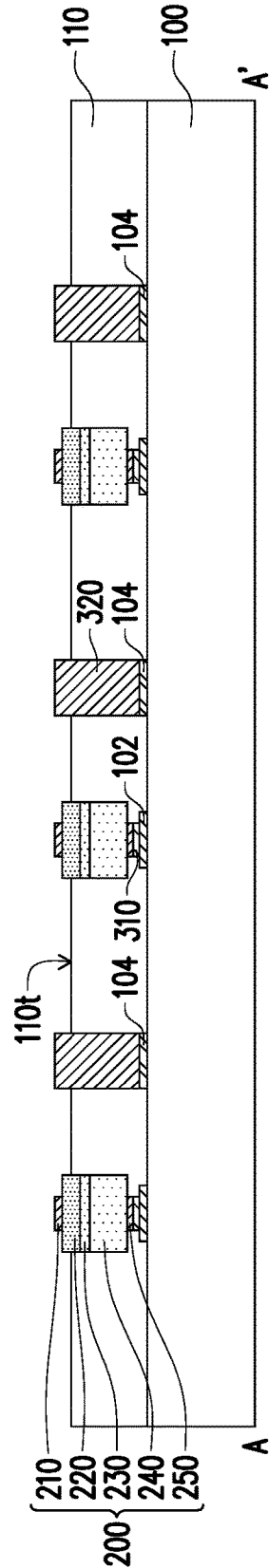


FIG. 14B

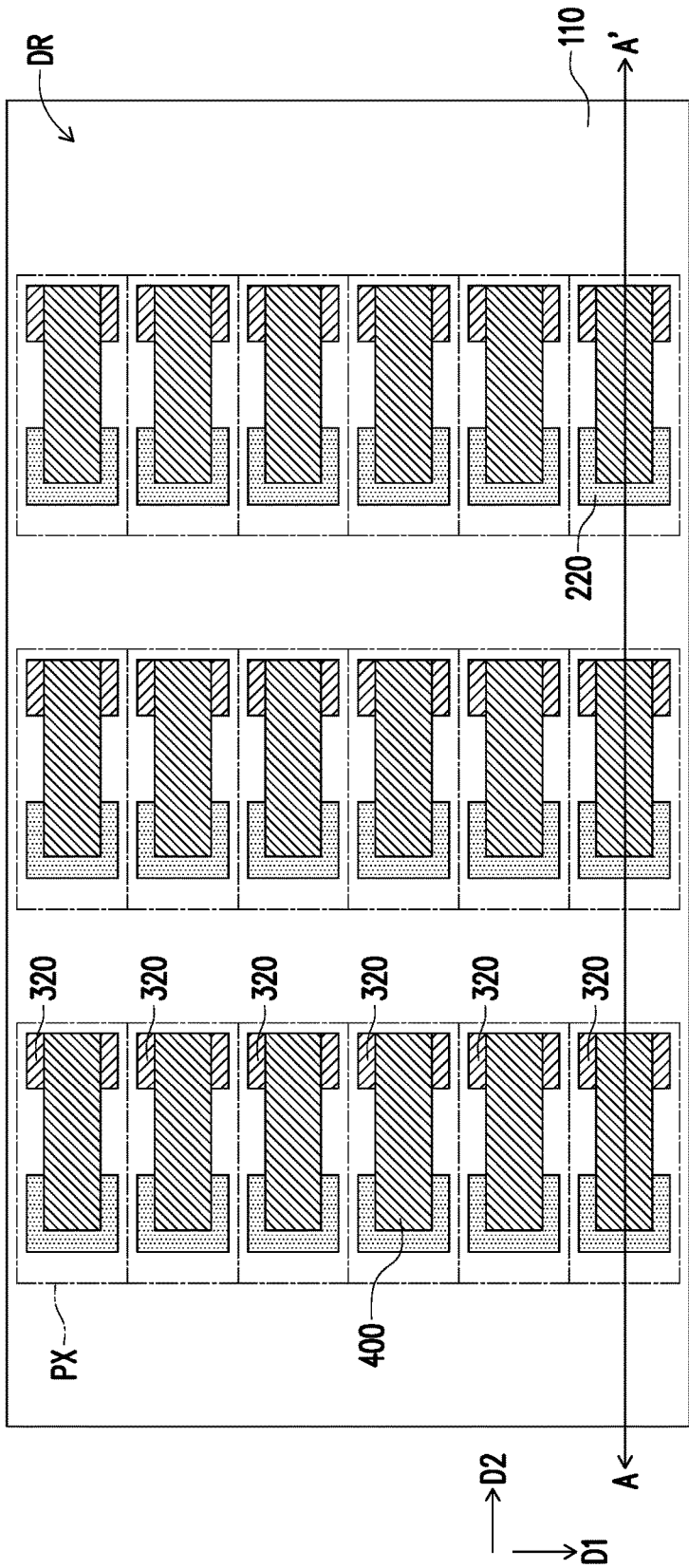


FIG. 15A

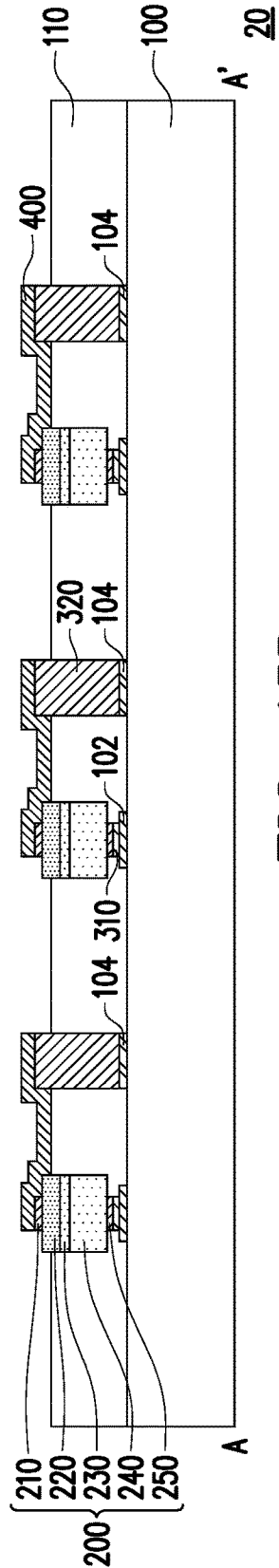


FIG. 15B



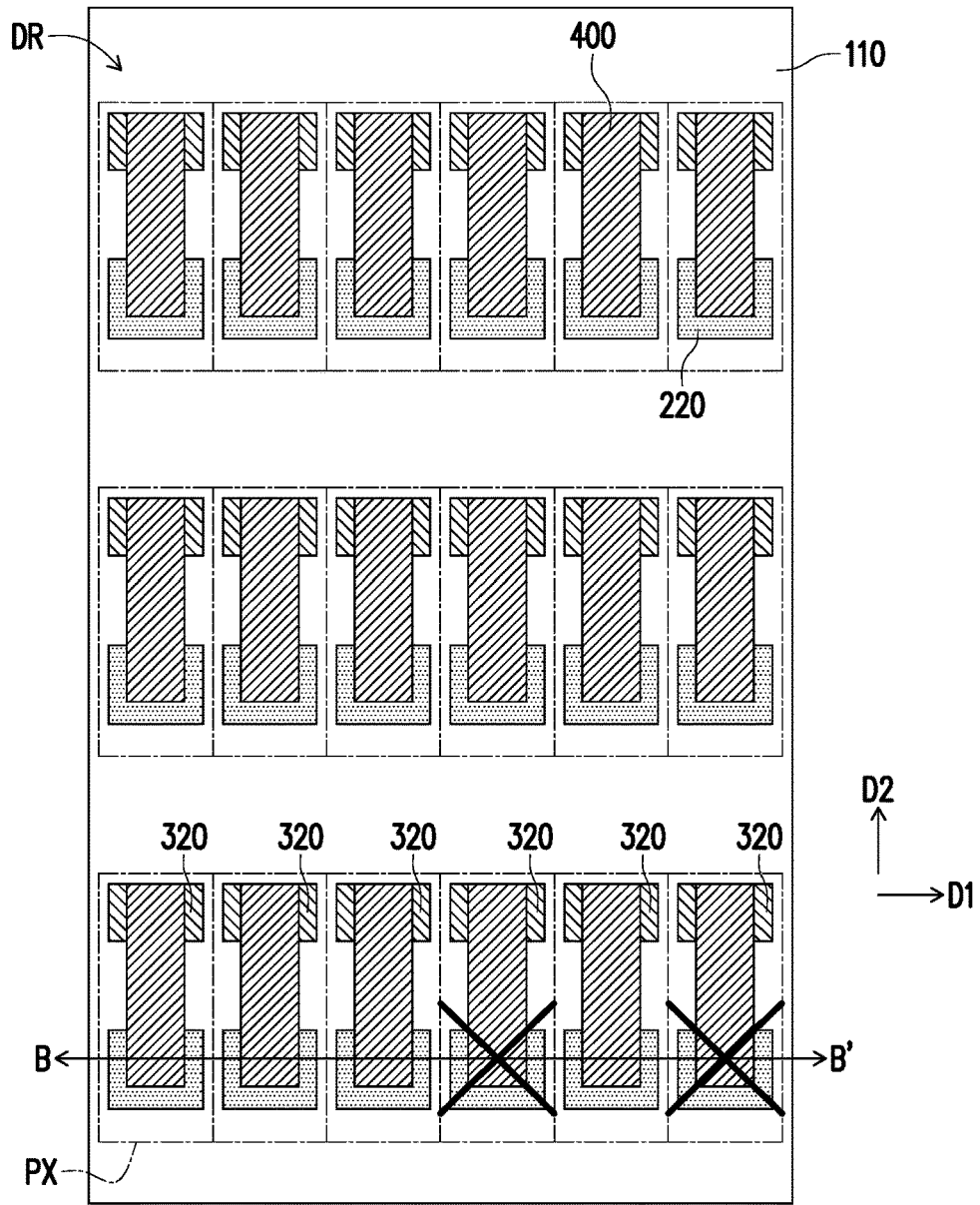


FIG. 16A

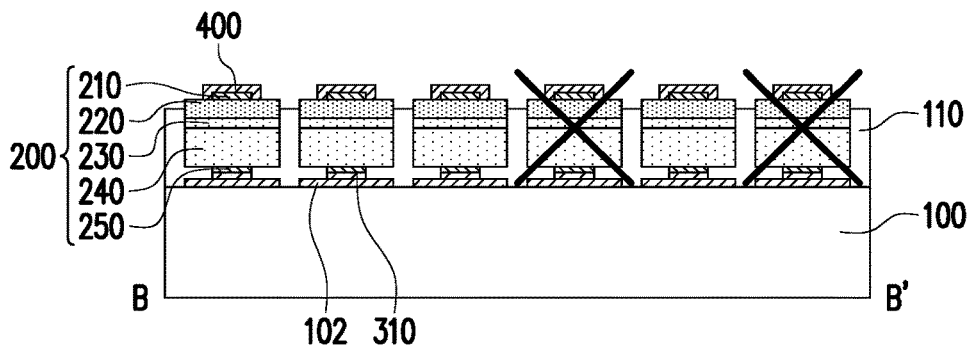


FIG. 16B

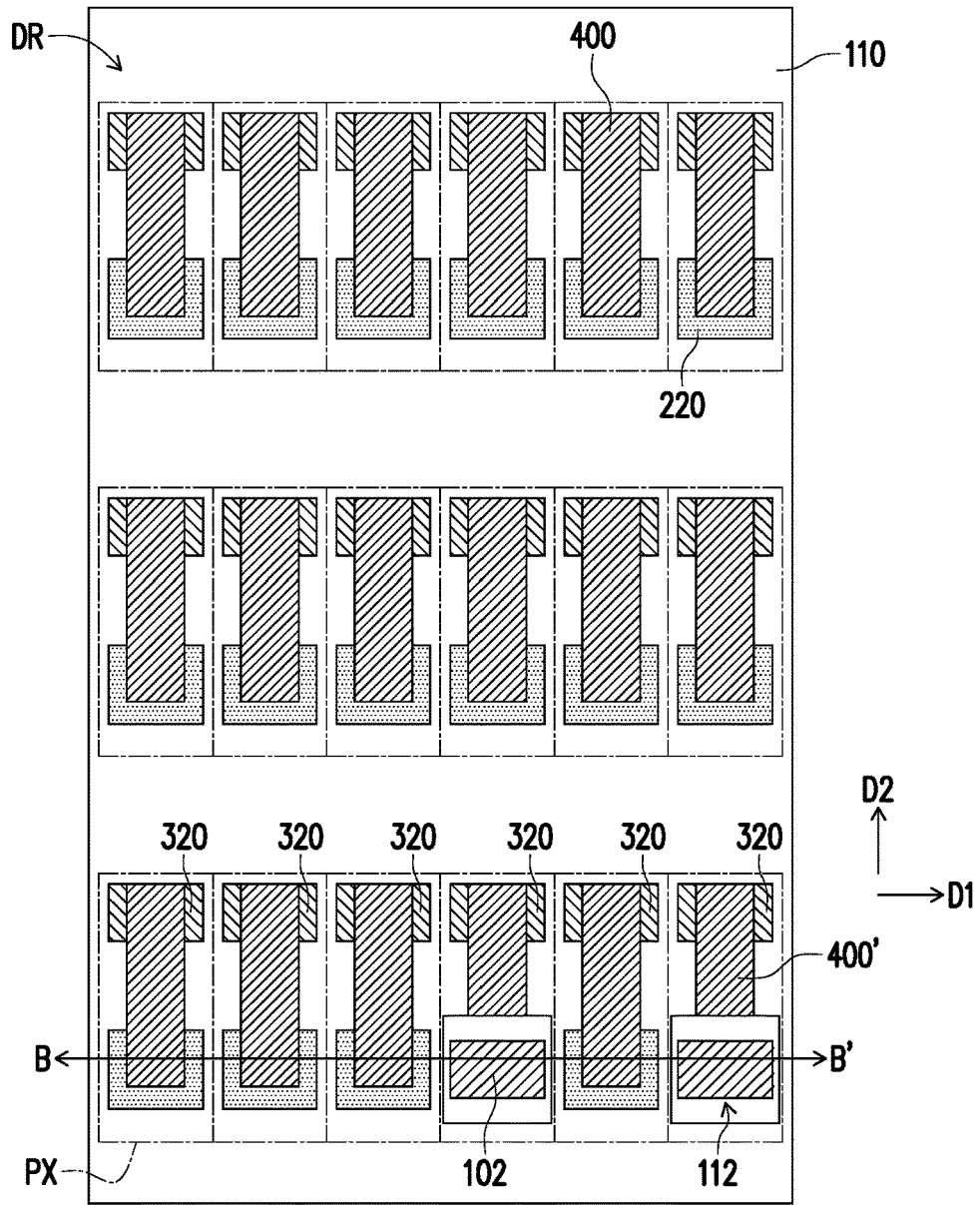


FIG. 17A

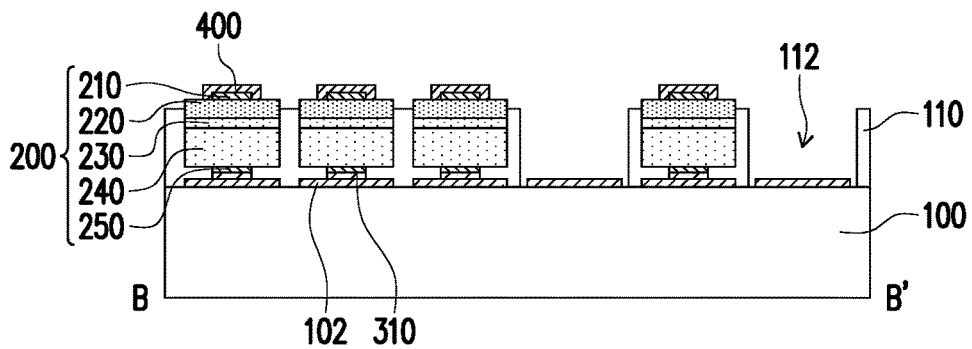


FIG. 17B

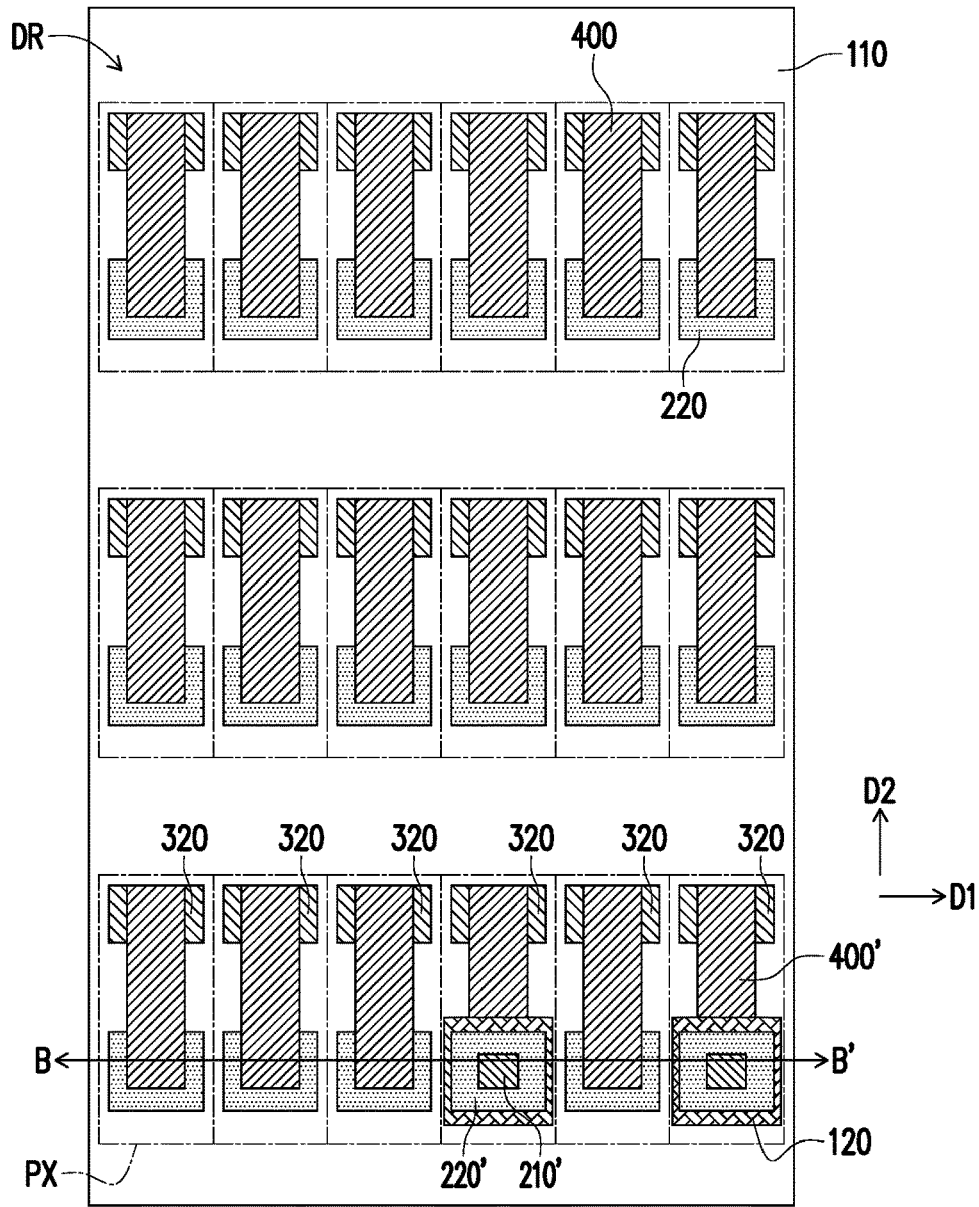


FIG. 18A

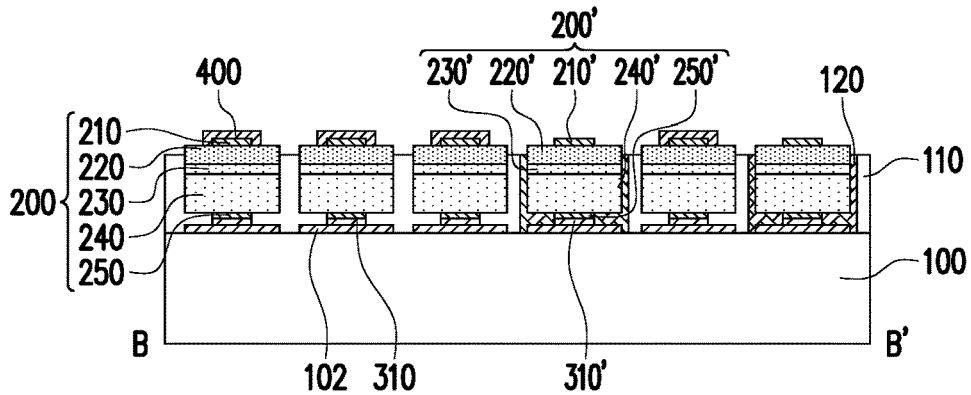
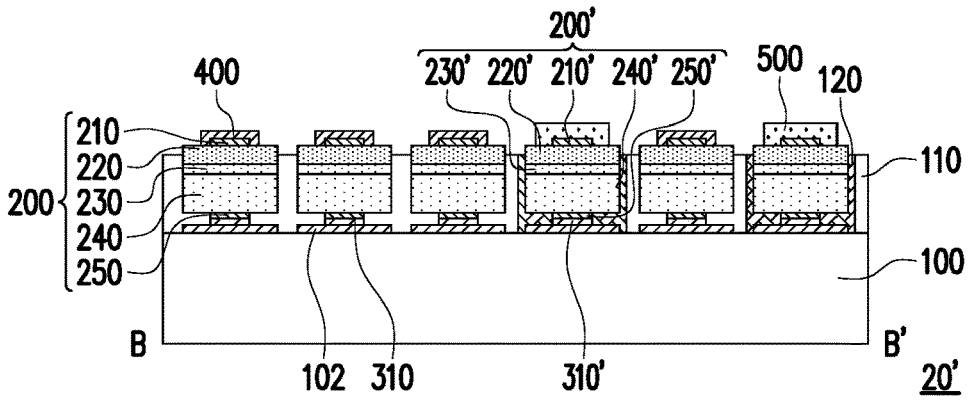
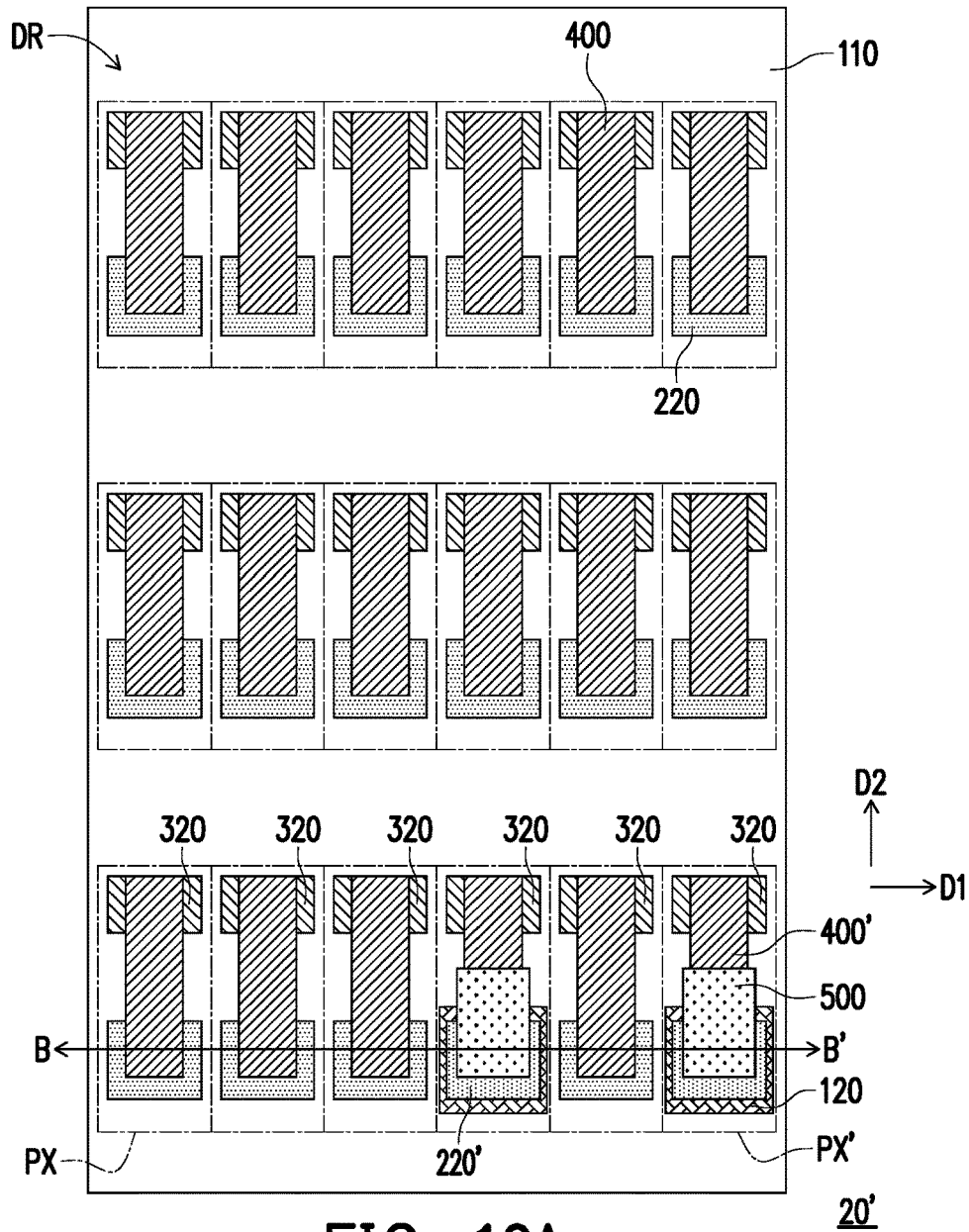


FIG. 18B





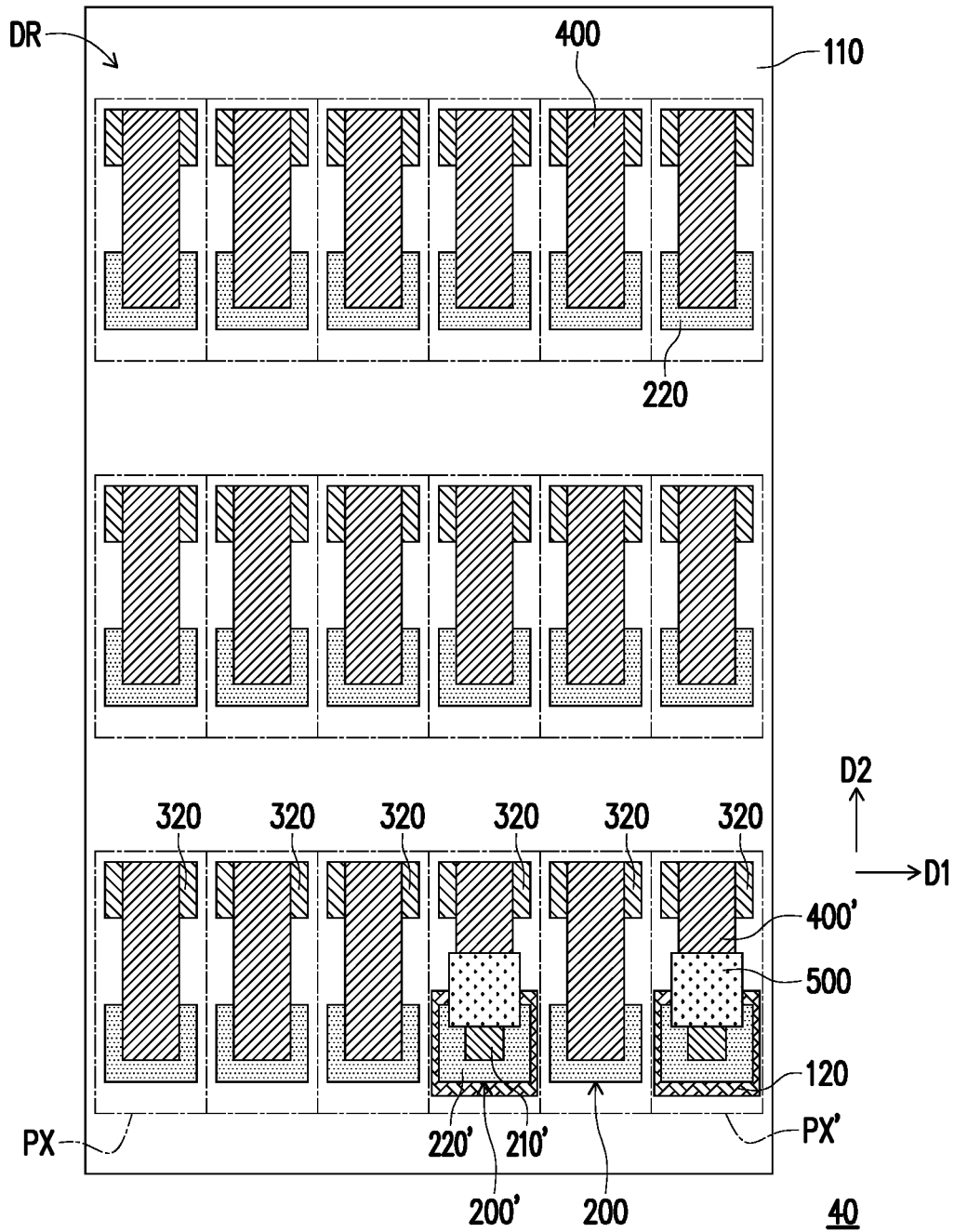


FIG. 21

## DISPLAY PANEL AND MANUFACTURING METHOD THEREOF

### CROSS-REFERENCE TO RELATED APPLICATION

**[0001]** This application claims the priority benefit of China application serial no. 202211511699.9 filed on Nov. 29, 2022. The entirety of the above-mentioned patent application is hereby incorporated by reference herein and made a part of this specification.

### BACKGROUND

#### Technical Field

**[0002]** The disclosure relates to a display panel and a manufacturing method thereof.

#### Description of Related Art

**[0003]** A light emitting diode is a kind of electroluminescent semiconductor element, which has the advantages of high efficiency, long service life, not easy to break, fast response speed, and high reliability. Generally speaking, the key technology for manufacturing micro light emitting diode displays is how to transfer a large number of micro light emitting diodes to the pixel array substrate. However, the transfer technology is a mechanical operation, and the effectiveness of the transfer technology depends on the precision of the machine and the precision and yield of the transfer device itself. When extracting the micro LEDs, one may encounter machine actuation errors and transfer device accuracy errors. When placing the micro LEDs, one may face another machine actual alignment deviation. If the micro LEDs are not placed in the correct position, or if there is damage during the transfer and placement process, the micro LEDs might not work properly. Generally speaking, pixels that are not working properly are repaired through a maintenance process. Therefore, many manufacturers are currently devoting themselves to developing methods that may improve the yield of the aforementioned maintenance process.

### SUMMARY

**[0004]** The disclosure provides a display panel, which may improve the problem of poor electrical connection between the light emitting diode and the pad due to the step difference.

**[0005]** The disclosure provides a manufacturing method of a display panel, which may improve the yield of the maintenance process.

**[0006]** At least one embodiment of the disclosure provides a display panel. The display panel includes a circuit substrate, multiple pixel structures, and a molding layer. The circuit substrate has multiple first pad structures and multiple second pad structures. The pixel structures are disposed above a display region of the circuit substrate. Each of at least a portion of the pixel structures includes a first light emitting diode, a first conductive block, and a first conductive connection structure. The first light emitting diode is disposed on a corresponding first pad structure. The first conductive block is disposed on a corresponding second pad structure. The first conductive connection structure electrically connects the first light emitting diode to the first conductive block. The molding layer is located above the

circuit substrate and surrounds the first light emitting diode and the first conductive block. The first conductive connection structure is located on the molding layer.

**[0007]** At least one embodiment of the disclosure provides a manufacturing method of a display panel, including the following operation. A circuit substrate is provided, in which the circuit substrate has multiple first pad structures and multiple second pad structures. Multiple conductive blocks are formed on the second pad structures. Multiple first light emitting diodes are disposed on the first pad structures. A molding layer is formed to surround the conductive blocks and the first light emitting diodes. Multiple first conductive connection structures are formed on the molding layer, in which the first conductive connection structures electrically connect at least a portion of the first light emitting diodes to at least a portion of the conductive blocks to form multiple pixel structures. A portion of the molding layer is removed to form an opening exposing at least a portion of the first pad structures. A second light emitting diode is disposed in the opening, and the second light emitting diode is bonded to at least a portion of the first pad structures. A second conductive connection structure is formed on the molding layer, in which the second conductive connection structure electrically connects the second light emitting diode to a corresponding one of the conductive blocks.

### BRIEF DESCRIPTION OF THE DRAWING

**[0008]** FIG. 1A, FIG. 2A, FIG. 3A, FIG. 4A, FIG. 5A, FIG. 6A, FIG. 7A, FIG. 8A, and FIG. 9A are top schematic views of a manufacturing method of a display panel according to an embodiment of the disclosure.

**[0009]** FIG. 1B, FIG. 2B, FIG. 3B, FIG. 4B, FIG. 5B, and FIG. 6B are cross-sectional schematic views along a line A-A' of FIG. 1A, FIG. 2A, FIG. 3A, FIG. 4A, FIG. 5A, and FIG. 6A, respectively.

**[0010]** FIG. 7B, FIG. 8B, and FIG. 9B are cross-sectional schematic views along a line B-B' of FIG. 7A, FIG. 8A, and FIG. 9A, respectively.

**[0011]** FIG. 10A, FIG. 11A, FIG. 12A, FIG. 13A, FIG. 14A, FIG. 15A, FIG. 16A, FIG. 17A, FIG. 18A, and FIG. 19A are top schematic views of a manufacturing method of a display panel according to an embodiment of the disclosure.

**[0012]** FIG. 10B, FIG. 11B, FIG. 12B, FIG. 13B, FIG. 14B, and FIG. 15B are cross-sectional schematic views along the line A-A' of FIG. 10A, FIG. 11A, FIG. 12A, FIG. 13A, FIG. 14A, and FIG. 15A, respectively.

**[0013]** FIG. 16B, FIG. 17B, FIG. 18B, and FIG. 19B are cross-sectional schematic views along the line B-B' of FIG. 16A, FIG. 17A, FIG. 18A, and FIG. 19A, respectively.

**[0014]** FIG. 20 is a top schematic view of a display panel according to an embodiment of the disclosure.

**[0015]** FIG. 21 is a top schematic view of a display panel according to an embodiment of the disclosure.

### DETAILED DESCRIPTION OF DISCLOSED EMBODIMENTS

**[0016]** FIG. 1A, FIG. 2A, FIG. 3A, FIG. 4A, FIG. 5A, FIG. 6A, FIG. 7A, FIG. 8A, and FIG. 9A are top schematic views of a manufacturing method of a display panel according to an embodiment of the disclosure. FIG. 1B, FIG. 2B, FIG. 3B, FIG. 4B, FIG. 5B, and FIG. 6B are cross-sectional schematic views along a line A-A' of FIG. 1A, FIG. 2A, FIG.

3A, FIG. 4A, FIG. 5A, and FIG. 6A, respectively. FIG. 7B, FIG. 8B, and FIG. 9B are cross-sectional schematic views along a line B-B' of FIG. 7A, FIG. 8A, and FIG. 9A, respectively. More specifically, FIG. 1A to FIG. 6B are schematic views of a manufacturing method of a display panel 10. When it is found that a portion of the pixel structures PX in the display panel 10 is faulty, the maintenance process shown in FIG. 7A to FIG. 9B is further performed to obtain the display panel 10'.

[0017] Referring to FIG. 1A and FIG. 1B, a circuit substrate 100 is provided. The circuit substrate 100 has multiple first pad structures 102 and multiple second pad structures 104 located on the surface. For example, the circuit substrate 100 includes a substrate and a circuit structure located on the substrate. The circuit structure includes conductive lines, active elements, passive elements, the first pad structure 102, the second pad structure 104, and other suitable components. For convenience of illustration, FIG. 1B and FIG. 1A show the first pad structure 102 and the second pad structure 104 in the circuit substrate 100, and other circuit structures in the circuit substrate 100 are omitted. The first pad structure 102 and the second pad structure 104 are disposed in the display region DR of the circuit substrate 100.

[0018] In this embodiment, the first pad structure 102 includes a first portion 102a and a second portion 102b that are separated from each other. The first portion 102a and the second portion 102b of the first pad structure 102 are electrically connected to each other through other conductive lines (not shown) or circuit structures. In other words, the same signal is applied to the first portion 102a and the second portion 102b. In other embodiments, the first portion 102a and the second portion 102b are connected to each other, in other words, the first pad structure 102 are not divided into two separate portions.

[0019] In this embodiment, the second pad structure 104 includes a third portion 104a and a fourth portion 104b that are separated from each other. The third portion 104a and the fourth portion 104b of the second pad structure 104 are electrically connected to each other through other conductive lines (not shown) or circuit structures. In other words, the same signal is applied to the third portion 104a and the fourth portion 104b. In other embodiments, the third portion 104a and the fourth portion 104b are connected to each other, in other words, the second pad structure 104 are not divided into two separate portions.

[0020] In this embodiment, in the first direction D1, the first portion 102a and the second portion 102b are arranged alternately, and the third portion 104a and the fourth portion 104b are arranged alternately. In the second direction D2, the first portion 102a and the third portion 104a are arranged alternately, and the second portion 102b and the fourth portion 104b are arranged alternately. In this embodiment, the first direction D1 is perpendicular to the second direction D2.

[0021] In this embodiment, the first pad structure 102 and the second pad structure 104 belong to the same patterned conductive layer. For example, the first pad structure 102 and the second pad structure 104 are formed by patterning the same conductive material layer. In some embodiments, the materials of the first pad structure 102 and the second pad structure 104 include metal, metal oxide, or other suitable materials. In some examples, each of the first pad

structure 102 and the second pad structure 104 is a single-layer or multi-layer structure.

[0022] Referring to FIG. 2A and FIG. 2B, multiple first conductive blocks 320a and multiple second conductive blocks 320b are formed on the second pad structure 104. The first conductive block 320a is formed on the third portion 104a of the second pad structure 104, and the second conductive block 320b is formed on the fourth portion 104b of the second pad structure 104. The first conductive block 320a is separated from the second conductive block 320b.

[0023] In some embodiments, the first conductive block 320a and the second conductive block 320b further include a seed crystal layer (not shown). For example, the forming method for the first conductive block 320a and the second conductive block 320b includes the following steps. First, a seed crystal layer and a patterned photoresist layer are formed on the circuit substrate 100. The seed crystal layer contacts the third portion 104a and the fourth portion 104b of the second pad structure 104, and the patterned photoresist layer has multiple openings exposing the third portion 104a and the fourth portion 104b. Then, a metal material is formed on the seed crystal layer in the openings of the patterned photoresist layer by electroplating. Finally, the patterned photoresist layer and the excess seed crystal layer are removed, and the remaining metal material and seed crystal layer form the first conductive block 320a and the second conductive block 320b. In some embodiments, the seed crystal layer includes titanium, copper, other suitable conductive materials or a combination of the materials thereof, and the metal material formed by the aforementioned electroplating includes gold, copper, other suitable metal materials or a combination of the materials thereof.

[0024] In some embodiments, the first conductive block 320a and the second conductive block 320b have the same thickness T, in which the thickness T is 5 microns to 10 microns.

[0025] Referring to FIG. 3A and FIG. 3B, multiple first light emitting diodes 200 are disposed on the first pad structure 102. In this embodiment, the first light emitting diode 200 is located on the first portion 102a of the corresponding first pad structure 102.

[0026] The first light emitting diode 200 is a vertical light emitting diode and includes a first electrode 210, a first semiconductor layer 220, a light emitting layer 230, a second semiconductor layer 240, and a second electrode 250. The first semiconductor layer 220, the light emitting layer 230, and the second semiconductor layer 240 are stacked in sequence. In some embodiments, one of the first semiconductor layer 220 and the second semiconductor layer 240 is an N-type semiconductor, and the other is a P-type semiconductor. The first electrode 210 and the second electrode 250 are respectively connected to the first semiconductor layer 220 and the second semiconductor layer 240. In this embodiment, the top surface area of the first electrode 210 is smaller than the top surface area of the first semiconductor layer 220, but the disclosure is not limited thereto. The top surface area of the first electrode 210 may be adjusted according to actual requirements. For example, in other embodiments, the top surface area of the first electrode 210 is equal to the top surface area of the first semiconductor layer 220. In some embodiments, the first light emitting diode 200 includes light emitting diodes of different colors. For example, the first light emitting diode 200 includes red light emitting diodes, green light emitting



diodes, blue light emitting diodes, or light emitting diodes of other colors. In some embodiments, the first light emitting diodes **200** of different colors are arranged in the first direction **D1**, and the first light emitting diodes **200** of the same color are arranged in the second direction **D2**, but the disclosure is not limited thereto. In other embodiments, the first light emitting diodes **200** of different colors are arranged in the second direction **D2**, and the first light emitting diodes **200** of the same color are arranged in the first direction **D1**.

[0027] In this embodiment, the second electrode **250** is bonded to the corresponding first portion **102a** of the first pad structure **102**. For example, the second electrode **250** is bonded to the first portion **102a** through the conductive connection structure **310**. The conductive connection structure **310** is, for example, anisotropic conductive glue, solder, or other suitable materials. In some embodiments, the second electrode **250** is eutectically bonded to the first portion **102a** of the first pad structure **102**.

[0028] In some embodiments, after bonding the first light emitting diode **200** to the first portion **102a**, the top surface of the first light emitting diode **200** (the top surface of the first electrode **210**) is approximately flush with the top surface of the first conductive block **320a** and the top surface of the second conductive block **320b**. In other words, based on the circuit substrate **100**, the top surface of the first light emitting diode **200** is approximately at the same horizontal level as the top surface of the first conductive block **320a** and the top surface of the second conductive block **320b**.

[0029] Referring to FIG. 4A and FIG. 4B, the molding layer **110** is formed on the circuit substrate **100**, and the molding layer **110** surrounds the first conductive block **320a**, the second conductive block **320b**, and the first light emitting diode **200**.

[0030] In some embodiments, the molding layer **110** includes transparent material, gray material, or black material. For example, the molding layer **110** includes epoxy resin, silicone, or other suitable materials, and the molding layer **110** selectively includes carbon black, scattering particles, or other filling particles.

[0031] In this embodiment, the molding layer **110** covers the top surface of the first conductive block **320a**, the top surface of the second conductive block **320b**, and the top surface of the first light emitting diode **200**. Therefore, plasma treatment must be performed to remove a portion of the molding layer **110** so that the first conductive block **320a**, the second conductive block **320b**, and the first light emitting diode **200** may be exposed, as shown in FIG. 5A and FIG. 5B. In some embodiments, the aforementioned plasma treatment is performed, for example, by sulfur hexafluoride plasma, carbon tetrafluoride plasma, oxygen plasma, or a combination thereof.

[0032] In some embodiments, the plasma treatment is performed until the top surface **110t** of the molding layer **110** is lower than the top surface of the first conductive block **320a**, the top surface of the second conductive block **320b**, and the top surface of the first light emitting diode **200**. However, in order to reduce the probability of short-circuiting the first light emitting diode **200**, the molding layer **110** preferably covers the light emitting layer **230** and the second semiconductor layer **240**. Specifically, based on the circuit substrate **100**, the height of the top surface **110t** of the molding layer **110** is preferably higher than the height of the light emitting layer **230** of the first light emitting diode **200**.

[0033] Next, referring to FIG. 6A and FIG. 6B, multiple first conductive connection structures **400** are formed on the molding layer **110**. The first conductive connection structure **400** electrically connects at least a portion of the first light emitting diode **200** to at least a portion of the first conductive block **320a** and the second conductive block **320b** to form multiple pixel structures **PX**. In this embodiment, the first pad structure **102** corresponding to each of the pixel structures **PX** includes a first portion **102a** and a second portion **102b** separated from each other, and the first pad structure **104** corresponding to each of the pixel structures **PX** includes a third portion **104a** and a fourth portion **104b** separated from each other.

[0034] In this embodiment, the first conductive connection structure **400** is an L-shaped structure formed by a portion extending along the first direction **D1** and a portion extending along the second direction **D2**, and the first conductive connection structure **400** is simultaneously connected to the first conductive block **320a** and the second conductive block **320b**. In other embodiments, the first conductive connection structure **400** is a straight strip structure, in which the first conductive connection structure **400** is connected to the first conductive block **320a** and not connected to the second conductive block **320b**.

[0035] In some embodiments, the first conductive connection structure **400** includes a transparent conductive material, such as a conductive oxide (e.g., indium tin oxide, indium zinc oxide, aluminum tin oxide, aluminum zinc oxide, indium gallium zinc oxide, or combination of the materials thereof), therefore, even if the first conductive connection structure **400** covers the top surface of the first light emitting diode **200**, it does not have a great impact on the brightness of the display panel **10**, but the disclosure is not limited thereto. In other embodiments, the first conductive connection structure **400** includes an opaque conductive material, such as metal, therefore, the area of the first conductive connection structure **400** covering the top surface of the first light emitting diode **200** may be reduced. Moreover, as shown in FIG. 20, the first conductive connection structure **400** only contacts the side of the first electrode **210** of the first light emitting diode **200**, so as to prevent the first conductive connection structure **400** from having a great impact on the brightness of the display panel **30**. In some embodiments, the forming method of the first conductive connection structure **400** includes physical vapor deposition, chemical vapor deposition, atomic layer deposition, printing, inkjet printing, or other suitable methods. In some embodiments, the defining method for the pattern of the first conductive connection structure **400** includes, for example, a lithography process.

[0036] In this embodiment, each of at least a portion of the pixel structures **PX** includes a first light emitting diode **200**, a first conductive block **320a**, a second conductive block **320b**, a first conductive connection structure **400**, and a repair region **RR**. Both the first light emitting diode **200** and the repairing region **RR** overlap the first pad structure **102**, in which the first light emitting diode **200** and the repairing region **RR** respectively overlap the first portion **102a** and the second portion **102b**.

[0037] After the first conductive connection structure **400** is formed, the pixel structures **PX** in the display panel **10** is inspected, and when a portion of the pixel structures **PX** is found to be faulty, the maintenance process shown in FIG. 7A to FIG. 9B is further performed. For example, a portion

of the pixel structures PX is a faulty pixel structure PX. In the faulty pixel structure PX, the first light emitting diode 200 and/or the first conductive connection structure 400 are damaged, causing the first light emitting diode 200 in the faulty pixel structure PX to fail to emit light normally. In FIG. 7A to FIG. 9B, a cross mark is marked on the first light emitting diode 200 that cannot emit light normally.

[0038] Referring to FIG. 7A and FIG. 7B, a portion of the molding layer 110 is removed to form an opening 112 exposing at least a portion of the first pad structure 102. Specifically, the opening 112 of the molding layer 110 is located in the repair region RR of the faulty pixel structure PX, and the opening 112 exposes the first pad structure 102 of the faulty pixel structure PX. In this embodiment, the opening 112 exposes the second portion 102b of the first pad structure 102.

[0039] In some embodiments, the removing method for a portion of the molding layer 110 includes a dry etching process (e.g., a laser process) or a wet etching process.

[0040] Referring to FIG. 8A and FIG. 8B, the second light emitting diode 200R is disposed in the opening 112. The second light emitting diode 200R is bonded to at least a portion of the first pad structure 102.

[0041] The second light emitting diode 200R is a vertical light emitting diode and includes a first electrode 210R, a first semiconductor layer 220R, a light emitting layer 230R, a second semiconductor layer 240R, and a second electrode 250R. The first semiconductor layer 220R, the light emitting layer 230R, and the second semiconductor layer 240R are stacked in sequence. In some embodiments, one of the first semiconductor layer 220R and the second semiconductor layer 240R is an N-type semiconductor, and the other is a P-type semiconductor. The first electrode 210R and the second electrode 250R are respectively connected to the first semiconductor layer 220R and the second semiconductor layer 240R. In some embodiments, the second light emitting diode 200R includes light emitting diodes of different colors. For example, the second light emitting diode 200R includes red light emitting diodes, green light emitting diodes, blue light emitting diodes, or light emitting diodes of other colors. In some embodiments, the first light emitting diode 200 and the second light emitting diode 200R in a faulty pixel structure PX are light emitting diodes of the same color.

[0042] In some embodiments, after the second light emitting diode 200R is disposed in the opening 112, a filling material 120 is formed to fill the gap between the second light emitting diode 200R and the opening 112. The second light emitting diode 200R and the filling material 120 are filled into the opening 112, and the filling material 120 surrounds the second light emitting diode 200R. In some embodiments, the forming method of the filling material 120 includes inkjet printing, glue dispensing, or other suitable processes. In some embodiments, the filling material 120 includes epoxy resin, silicone, acrylic or other suitable materials, and the filling material 120 selectively includes carbon black, scattering particles, or other filling particles. The filling material 120 and the molding layer 110 may include the same or different materials.

[0043] Referring to FIG. 9A and FIG. 9B, a second conductive connection structure 500 is formed on the molding layer 110. The second conductive connection structure 500 electrically connects the second light emitting diode

200R to a corresponding one of the conductive blocks, and so far the display panel 10' including the repaired pixel structure PX' is formed.

[0044] In some embodiments, the second conductive connection structure 500 includes a transparent or opaque conductive material formed by glue dispensing, inkjet printing, or other suitable methods, but the disclosure is not limited thereto. In other embodiments, the second conductive connection structure 500 includes conductive materials formed by chemical vapor deposition, such as tungsten, other metal materials, or other suitable conductive materials. In some embodiments, the first conductive connection structure 400 and the second conductive connection structure 500 include the same or different materials.

[0045] Each of the repaired pixel structures PX' includes the first light emitting diode 200, the second light emitting diode 200R, the first conductive block 320a, the second conductive block 320b, the first conductive connection structure 400, the filling material 120, and the second conductive connection structure 500. The first light emitting diode 200 and the second light emitting diode 200R are respectively disposed on the first portion 102a and the second portion 102b of the first pad structure 102. The first conductive block 320a and the second conductive block 320b are respectively disposed on the third portion 104a and the fourth portion 104b of the second pad structure 104. The first conductive connection structure 400 and the second conductive connection structure 500 are located on the molding layer 110. The second conductive connection structure 500 electrically connects the second light emitting diode 200R to the second conductive block 320b. In this embodiment, the first light emitting diode 200 in the repaired pixel structure PX' is not removed, but the disclosure is not limited thereto. In other embodiments, the first light emitting diode 200 in the repaired pixel structure PX' is removed through an additional process.

[0046] In the repaired pixel structure PX' of this embodiment, since the first conductive connection structure 400 is L-shaped, the second conductive connection structure 500 electrically connects the first electrode 210R of the second light emitting diode 200R to the first conductive connection structure 400, and the second conductive connection structure 500 is electrically connected to the second conductive block 320b through the first conductive connection structure 400. The horizontal distance L1 between the second light emitting diode 200R and the first conductive connection structure 400 is smaller than the horizontal distance L2 between the second light emitting diode 200R and the second conductive block 320b. In other words, with the design of the first conductive connection structure 400, the second conductive connection structure 500 may be electrically connected to the first conductive block 320a and the second conductive block 320b without directly contacting the first conductive block 320a or the second conductive block 320b. Therefore, the size of the second conductive connection structure 500 may be reduced, and the impact of the second conductive connection structure 500 on the brightness of the display panel 10' may be reduced.

[0047] In this embodiment, since the conductive connection structure 500 is formed on the molding layer 110, and may be electrically connected to the second pad structure 104 through the first conductive block 320a and/or the second conductive block 320b, therefore, it is possible to prevent disconnection of the conductive connection struc-

ture **500** caused by the step difference between the first electrode **210R** of the second light emitting diode **200R** and the second pad structure **104** and improve the yield of the maintenance process.

[0048] FIG. 10A, FIG. 11A, FIG. 12A, FIG. 13A, FIG. 14A, FIG. 15A, FIG. 16A, FIG. 17A, FIG. 18A, and FIG. 19A are top schematic views of a manufacturing method of a display panel according to an embodiment of the disclosure. FIG. 10B, FIG. 11B, FIG. 12B, FIG. 13B, FIG. 14B, and FIG. 15B are cross-sectional schematic views along the line A-A' of FIG. 10A, FIG. 11A, FIG. 12A, FIG. 13A, FIG. 14A, and FIG. 15A, respectively. FIG. 16B, FIG. 17B, FIG. 18B, and FIG. 19B are cross-sectional schematic views along the line B-B' of FIG. 16A, FIG. 17A, FIG. 18A, and FIG. 19A, respectively. More specifically, FIG. 10A to FIG. 15B are schematic views of a manufacturing method of a display panel **20**. When it is found that a portion of the pixel structures PX in the display panel **20** is faulty, the maintenance process shown in FIG. 16A to FIG. 19B is further performed to obtain the display panel **20'**.

[0049] It is noted that the embodiment of FIG. 10A to FIG. 19B uses the reference numerals and a part of the contents of the embodiment of FIG. 1A to FIG. 9B, and the same or similar reference numerals are used to denote the same or similar elements, and the description of the same technical content is omitted. For the description of the omitted portion, reference may be made to the foregoing embodiment, and details are not described herein.

[0050] Referring to FIG. 10A and FIG. 10B, a circuit substrate **100** is provided. The circuit substrate **100** has multiple first pad structures **102** and multiple second pad structures **104** located on the surface. In this embodiment, each of the first pad structures **102** does not include multiple portions separated from each other, and each of the second pad structures **104** does not include multiple portions separated from each other.

[0051] In this embodiment, the first pad structures **102** are arranged along the first direction D1, and the second pad structures **104** are arranged along the first direction D1. In the second direction D2, the first pad structures **102** and the second pad structures **104** are arranged alternately.

[0052] Referring to FIG. 11A and FIG. 11B, multiple first conductive blocks **320** are formed on the second pad structures **104**.

[0053] In some embodiments, the first conductive block **320** further includes a seed crystal layer (not shown). For example, the forming method of the first conductive block **320** includes the following steps. First, a seed crystal layer and a patterned photoresist layer are formed on the circuit substrate **100**, in which the seed crystal layer contacts the second pad structure **104**, and the patterned photoresist layer has an opening exposing the second pad structure **104**. Then, a metal material is formed in the opening of the patterned photoresist layer by electroplating. Finally, the patterned photoresist layer and the excess seed crystal layer are removed, and the remaining metal material and seed crystal layer form the first conductive block **320**. In some embodiments, the seed crystal layer includes titanium, chromium, copper, other suitable conductive materials or a combination of the materials thereof, and the metal material formed by the aforementioned electroplating includes gold, copper, other suitable metal materials or a combination of the materials thereof.

[0054] In some embodiments, the thickness T of the first conductive block **320** is 5 microns to 10 microns.

[0055] Referring to FIG. 12A and FIG. 12B, multiple first light emitting diodes **200** are disposed on the first pad structure **102**. In some embodiments, the first light emitting diode **200** includes light emitting diodes of different colors. For example, the first light emitting diode **200** includes red light emitting diodes, green light emitting diodes, blue light emitting diodes, or light emitting diodes of other colors. In some embodiments, the first light emitting diodes **200** of different colors are arranged in the first direction D1, and the first light emitting diodes **200** of the same color are arranged in the second direction D2, but the disclosure is not limited thereto. In other embodiments, the first light emitting diodes **200** of different colors are arranged in the second direction D2, and the first light emitting diodes **200** of the same color are arranged in the first direction D1. In some embodiments, two rows of the first light emitting diodes **200** of the same color are arranged together. For example, two rows of red light emitting diodes are arranged together, two rows of green light emitting diodes are arranged together, and two rows of blue light emitting diodes are arranged together. In this case, two adjacent light emitting diodes of the same color may be turned on and off at the same time.

[0056] In this embodiment, the second electrode **250** is bonded to the corresponding first pad structure **102**. For example, the second electrode **250** is bonded to the first pad structure **102** through the conductive connection structure **310**. In some embodiments, the second electrode **250** is eutectically bonded to the first pad structure **102**.

[0057] In some embodiments, after bonding the first light emitting diode **200** to the first pad structure **102**, the top surface of the first light emitting diode **200** (the top surface of the first electrode **210**) is approximately flush with the top surface of the first conductive block **320**. In other words, based on the circuit substrate **100**, the top surface of the first light emitting diode **200** is approximately at the same horizontal level as the first conductive block **320**.

[0058] Referring to FIG. 13A and FIG. 13B, the molding layer **110** is formed on the circuit substrate **100**, and the molding layer **110** surrounds the first conductive block **320** and the first light emitting diode **200**.

[0059] In this embodiment, the molding layer **110** covers the top surface of the first conductive block **320** and the top surface of the first light emitting diode **200**. Therefore, plasma treatment must be performed to remove a portion of the molding layer **110** so that the first conductive block **320** and the first light emitting diode **200** may be exposed, as shown in FIG. 14A and FIG. 14B. In some embodiments, the aforementioned plasma treatment is performed, for example, by sulfur hexafluoride plasma, carbon tetrafluoride plasma, oxygen plasma, or a combination thereof.

[0060] In some embodiments, the plasma treatment is performed until the top surface **110'** of the molding layer **110** is lower than the top surface of the first conductive block **320** and the top surface of the first light emitting diode **200**. However, in order to reduce the probability of short-circuiting the first light emitting diode **200**, the molding layer **110** preferably covers the light emitting layer **230** and the second semiconductor layer **240**. Specifically, based on the circuit substrate **100**, the height of the top surface **110'** of the molding layer **110** is preferably higher than the height of the light emitting layer **230** of the first light emitting diode **200**.

[0061] Next, referring to FIG. 15A and FIG. 15B, multiple first conductive connection structures 400 are formed on the molding layer 110. The first conductive connection structure 400 electrically connects at least a portion of the first light emitting diode 200 to at least a portion of the first conductive block 320 to form multiple pixel structures PX. In this embodiment, the first conductive connection structure 400 is a straight strip extending along the first direction D1.

[0062] In this embodiment, each of the pixel structures PX corresponds to a first pad structure 102 and a second pad structure 104. In this embodiment, each of at least a portion of the pixel structures PX includes a first light emitting diode 200, a first conductive block 320, and a first conductive connection structure 400. The first light emitting diode 200 and the first conductive block 320 respectively overlap the first pad structure 102 and the second pad structure 104.

[0063] In other embodiments, each of the pixel structures PX corresponds to two adjacent first pad structures 102 and corresponding two second pad structures 104, and each of at least a portion of the pixel structures PX includes two adjacent first light emitting diodes 200, two adjacent first conductive blocks 320, and two adjacent first conductive connection structures 400. In the case that each of the pixel structures PX includes two first light emitting diodes 200, even if one of the first light emitting diodes 200 in the pixel structure PX is damaged, one may choose not to repair the pixel structure PX.

[0064] After the first conductive connection structure 400 is formed, the pixel structures PX in the display panel 20 is inspected, and when a portion of the pixel structures PX is found to be faulty, the maintenance process shown in FIG. 16A to FIG. 19B is further performed. For example, a portion of the pixel structures PX is a faulty pixel structure PX. In the faulty pixel structure PX, the first light emitting diode 200 and/or the first conductive connection structure 400 are damaged, causing the first light emitting diode 200 in the faulty pixel structure PX to fail to emit light normally. In FIG. 16A to FIG. 19B, a cross mark is marked on the first light emitting diode 200 that cannot emit light normally.

[0065] Referring to FIG. 17A and FIG. 17B, a portion of the molding layer 110 is removed to form an opening 112 exposing at least a portion of the first pad structure 102. In this embodiment, at least one faulty first light emitting diode 200 is located in the removed portion of the molding layer 110, and the faulty first light emitting diode 200 is removed, so that at least a portion of the first pad structure 102 under the faulty first light emitting diode 200 is exposed.

[0066] In some embodiments, the removing method for a portion of the molding layer 110 includes a dry etching process (e.g., a laser process) or a wet etching process. In some embodiments, the removing method of the faulty first light emitting diode 200 includes a laser (e.g., ultraviolet laser or infrared laser) process, vacuum extraction, or other suitable methods.

[0067] In this embodiment, a portion of the first conductive connection structure 400 is also removed to form the first conductive connection structure 400'. For example, at least a portion of the first conductive connection structure 400 on the first light emitting diode 200 in the faulty pixel structure PX is removed. The size of the first conductive connection structure 400' in the faulty pixel structure PX is smaller than the size of the first conductive connection structure 400 in the non-faulty pixel structure PX.

[0068] Referring to FIG. 18A and FIG. 18B, the first light emitting diode 200' for repairing is disposed in the opening 112. The first light emitting diode 200' is bonded to at least a portion of the first pad structure 102.

[0069] The first light emitting diode 200' is a vertical light emitting diode and includes a first electrode 210', a first semiconductor layer 220', a light emitting layer 230', a second semiconductor layer 240', and a second electrode 250'. The first semiconductor layer 220', the light emitting layer 230', and the second semiconductor layer 240' are stacked in sequence. In some embodiments, one of the first semiconductor layer 220' and the second semiconductor layer 240' is an N-type semiconductor, and the other is a P-type semiconductor. The first electrode 210' and the second electrode 250' are respectively connected to the first semiconductor layer 220' and the second semiconductor layer 240'. In some embodiments, the first light emitting diode 200' includes light emitting diodes of different colors. For example, the first light emitting diode 200' includes red light emitting diodes, green light emitting diodes, blue light emitting diodes, or light emitting diodes of other colors. In some embodiments, the first light emitting diode 200' used for repairing the faulty pixel structure PX and the original first light emitting diode 200 in the pixel structure PX are light emitting diodes of the same color.

[0070] In some embodiments, after the first light emitting diode 200' is disposed in the opening 112, a filling material 120 is formed to fill the gap between the first light emitting diode 200' and the opening 112. The first light emitting diode 200' and the filling material 120 are filled into the opening 112, and the filling material 120 surrounds the first light emitting diode 200'. In some embodiments, the forming method of the filling material 120 includes inkjet printing, glue dispensing, or other suitable processes. In some embodiments, the filling material 120 includes epoxy resin, silicone, acrylic or other suitable materials, and the filling material 120 selectively includes carbon black, scattering particles, or other filling particles. The filling material 120 and the molding layer 110 may include the same or different materials.

[0071] Referring to FIG. 19A and FIG. 19B, a second conductive connection structure 500 is formed on the molding layer 110. The second conductive connection structure 500 electrically connects the first light emitting diode 200' to a corresponding one of the conductive blocks, and so far the display panel 20' including the repaired pixel structure PX' is formed.

[0072] Each of the repaired pixel structures PX' includes the first light emitting diode 200', the first conductive block 320, the first conductive connection structure 400', the filling material 120, and the second conductive connection structure 500. The first light emitting diode 200' is disposed on the first pad structure 102. The first conductive block 320 is disposed on the second pad structure 104. The first conductive connection structure 400' and the second conductive connection structure 500 are located on the molding layer 110. The second conductive connection structure 500 and the first conductive connection structure 400' electrically connect the first light emitting diode 200' to the first conductive block 320.

[0073] In this embodiment, since the conductive connection structure 500 is formed on the molding layer 110, and may be electrically connected to the second pad structure 104 through the first conductive block 320, therefore, it is

possible to prevent disconnection of the conductive connection structure 500 caused by the step difference between the first electrode 210' of the first light emitting diode 200' and the second pad structure 104 and improve the yield of the maintenance process.

[0074] FIG. 20 is a top schematic view of a display panel according to an embodiment of the disclosure. It is noted that the embodiment of FIG. 20 uses the reference numerals and a part of the contents of the embodiment of FIG. 1A to FIG. 9B, and the same or similar reference numerals are used to denote the same or similar elements, and the description of the same technical content is omitted. For the description of the omitted portion, reference may be made to the foregoing embodiment, and details are not described herein.

[0075] The difference between the display panel 30 in FIG. 20 and the display panel 10' in FIG. 9B is that: in the display panel 30, the first conductive connection structure 400 and the second conductive connection structure 500 do not overlap at least a portion of the top surface of the first electrode 210 of the first light emitting diode 200 and at least a portion of the top surface of the first electrode 210R of the second light emitting diode 200R.

[0076] Referring to FIG. 20, in this embodiment, both the first conductive connection structure 400 and the second conductive connection structure 500 include a metal material, which is formed through a chemical vapor deposition process. In order to reduce the area covered by the first conductive connection structure 400 and the second conductive connection structure 500, the first conductive connection structure 400 is connected to the side surface of the first electrode 210 of the first light emitting diode 200 and exposes at least a portion of the top surface of the first electrode 210, and the second conductive connection structure 500 is connected to the side surface of the first electrode 210R of the second light emitting diode 200R and exposes at least a portion of the top surface of the first electrode 210R.

[0077] In this embodiment, it is taken as an example that both the first conductive connection structure 400 and the second conductive connection structure 500 include opaque conductive materials, but the disclosure is not limited thereto. In other embodiments, the first conductive connection structure 400 includes a transparent conductive material, and the second conductive connection structure 500 includes an opaque conductive material. In this case, even if the first conductive connection structure 400 covers the top surface of the first electrode 210 of the first light emitting diode 200, it does not have a great impact on the brightness of the display panel 30.

[0078] FIG. 21 is a top schematic view of a display panel according to an embodiment of the disclosure. It is noted that the embodiment of FIG. 21 uses the reference numerals and a part of the contents of the embodiment of FIG. 10A to FIG. 19B, and the same or similar reference numerals are used to denote the same or similar elements, and the description of the same technical content is omitted. For the description of the omitted portion, reference may be made to the foregoing embodiment, and details are not described herein.

[0079] The difference between the display panel 40 in FIG. 21 and the display panel 20' in FIG. 19B is that: in the display panel 40, the second conductive connection structure

500 does not overlap at least a portion of the top surface of the first electrode 210' of the first light emitting diode 200'.

[0080] Referring to FIG. 21, in this embodiment, the first conductive connection structure 400 includes a transparent conductive material, and the second conductive connection structure 500 includes an opaque conductive material. Even if the first conductive connection structure 400 covers the top surface of the first electrode 210 of the first light emitting diode 200, it does not have a great impact on the brightness of the display panel 40.

[0081] In this embodiment, the second conductive connection structure 500 includes a metal material and is formed through a chemical vapor deposition process. In order to reduce the area covered by the second conductive connection structure 500, the second conductive connection structure 500 is connected to the side surface of the first electrode 210' of the first light emitting diode 200' and exposes the top surface of the first electrode 210'.

[0082] To sum up, through the disposition of the molding layer and the conductive block, the problem of poor electrical connection between the light emitting diode and the pad due to the step difference may be improved.

What is claimed is:

1. A display panel, comprising:

a circuit substrate, having a plurality of first pad structures and a plurality of second pad structures;

a plurality of pixel structures, disposed above a display region of the circuit substrate, and each of at least a portion of the pixel structures comprising:

a first light emitting diode, disposed on a corresponding first pad structure among the first pad structures;

a first conductive block, disposed on a corresponding second pad structure among the second pad structures; and

a first conductive connection structure, electrically connecting the first light emitting diode to the first conductive block; and

a molding layer, located above the circuit substrate and surrounding the first light emitting diodes and the first conductive blocks, wherein the first conductive connection structures are located on the molding layer.

2. The display panel according to claim 1, wherein one of the pixel structures is a repaired pixel structure, and the repaired pixel structure further comprises a second light emitting diode and a second conductive block, the second light emitting diode and the second conductive block are respectively disposed on the corresponding first pad structure and the corresponding second pad structure, and the repaired pixel structure further comprises:

a second conductive connection structure, electrically connecting the second light emitting diode to the second conductive block, wherein the second conductive connection structure is located on the molding layer.

3. The display panel according to claim 2, wherein in the repaired pixel structure, the first light emitting diode and the second light emitting diode are respectively located on a first portion and a second portion of the corresponding first pad structure, wherein the first portion and the second portion are structurally separated from each other.

4. The display panel according to claim 2, wherein in the repaired pixel structure, the first conductive block and the second conductive block are respectively disposed on a third portion and a fourth portion of the corresponding second pad

structure, wherein the third portion and the fourth portion are structurally separated from each other.

5. The display panel according to claim 2, further comprising:

a filling material, wherein the second light emitting diode and the filling material are filled into an opening of the molding layer, and the filling material surrounds the second light emitting diode.

6. The display panel according to claim 2, wherein the second conductive connection structure electrically connects a first electrode of the second light emitting diode to the first conductive connection structure, wherein a horizontal distance between the second light emitting diode and the first conductive connection structure is smaller than a horizontal distance between the second light emitting diode and the second conductive block.

7. The display panel according to claim 2, wherein the second conductive connection structure is connected to a side surface of an electrode of the second light emitting diode, and the second conductive connection structure does not overlap at least a portion of the top surface of the electrode of the second light emitting diode.

8. The display panel according to claim 1, wherein the first conductive connection structure is connected to a side surface of an electrode of the first light emitting diode, and the first conductive connection structure does not overlap at least a portion of the top surface of the electrode of the first light emitting diode.

9. The display panel according to claim 1, wherein taking the circuit substrate as a basis, a height of a top surface of the molding layer is higher than a height of a light emitting layer of the first light emitting diode.

10. The display panel according to claim 1, wherein the first conductive connection structure and the second conductive connection structure comprise different materials.

11. The display panel according to claim 1, wherein the molding layer comprises transparent material, gray material, or black material.

12. The display panel according to claim 1, wherein each of the at least a portion of the pixel structures further comprises a second conductive block, the second conductive block is disposed on the corresponding second pad structure, and the first conductive connection structure is connected to the first conductive block and the second conductive block simultaneously.

13. The display panel according to claim 1, wherein a thickness of the first conductive block is 5 microns to 10 microns.

14. The display panel according to claim 1, wherein one of the at least a portion of the pixel structures is a repaired pixel structure, and the repaired pixel structure further comprises:

a second conductive connection structure, electrically connected to the first light emitting diode and the first conductive block, wherein the second conductive connection structure is located on the molding layer.

15. A manufacturing method of a display panel, comprising:

providing a circuit substrate, wherein the circuit substrate has a plurality of first pad structures and a plurality of second pad structures;

forming a plurality of conductive blocks on the second pad structures;

disposing a plurality of first light emitting diodes on the first pad structures;

forming a molding layer to surround the conductive blocks and the first light emitting diodes;

forming a plurality of first conductive connection structures on the molding layer, wherein the first conductive connection structures electrically connect at least a portion of the first light emitting diodes to at least a portion of the conductive blocks to form a plurality of pixel structures;

removing a portion of the molding layer to form an opening exposing at least a portion of the first pad structures;

disposing a second light emitting diode in the opening, and bonding the second light emitting diode to the at least a portion of the first pad structures; and

forming a second conductive connection structure on the molding layer, wherein the second conductive connection structure electrically connects the second light emitting diode to a corresponding one of the conductive blocks.

16. The manufacturing method of the display panel according to claim 15, wherein forming the conductive blocks comprises electroplating.

17. The manufacturing method of the display panel according to claim 15, further comprising:

forming a filling material to fill a gap between the second light emitting diode and the opening after disposing the second light emitting diode in the opening.

18. The manufacturing method of the display panel according to claim 15, further comprising:

wherein one of the first light emitting diodes is located in the portion of the molding layer, and the one of the first light emitting diodes is removed to expose the at least a portion of the first pad structures under the one of the first light emitting diodes.

19. The manufacturing method of the display panel according to claim 15, wherein each of the pixel structures comprises a repair region, and the opening of the molding layer is located in a portion of the repair regions.

20. The manufacturing method of the display panel according to claim 19, wherein each of the first pad structures comprises a first portion and a second portion separated from each other, wherein the first light emitting diodes are disposed on the first portion, and the repair regions overlap the second portions.

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